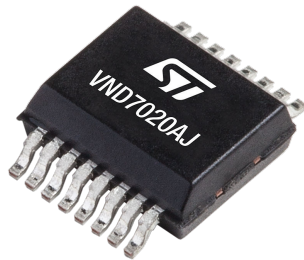


# Double channel high-side driver with MultiSense analog feedback for automotive applications

## Features



|                                   |       |           |
|-----------------------------------|-------|-----------|
| Max transient supply voltage      | VCC   | 40 V      |
| Operating voltage range           | VCC   | 4 to 28 V |
| Typ. on-state resistance (per Ch) | RON   | 22 mΩ     |
| Current limitation (typ)          | ILIMH | 63 A      |
| Standby current (max)             | ISTBY | 0.5 μA    |

- AEC-Q100 qualified 
- General
  - Double channel smart high side driver with MultiSense analog feedback
  - Very low standby current
  - Compatible with 3 V and 5 V CMOS outputs
- MultiSense diagnostic functions
  - Multiplexed analog feedback of: load current with high precision proportional current mirror, V<sub>CC</sub> supply voltage and

Product status link

[VND7020AJ](#)

## Applications

- All types of Automotive resistive, inductive and capacitive loads
- Specially intended for automotive turn indicators (up to 2x P27W or SAE1156 and R5W paralleled or LED rear combinations)

## Description

The device is a double channel high-side driver manufactured using ST proprietary VIPower® M07 technology and housed in PowerSSO-16 package. The device is designed to drive 12 V automotive grounded loads through a 3 V and 5 V CMOS-compatible interface, providing protection and diagnostics.

The device integrates advanced protective functions such as load current limitation, overload active management by power limitation and overtemperature shutdown with configurable latch-off.

A FaultRST pin unlatches the output in case of fault or disables the latch-off functionality.

A dedicated multifunction multiplexed analog output pin delivers sophisticated diagnostic functions including high precision proportional load current sense, supply voltage feedback and chip temperature sense, in addition to the detection of overload and short circuit to ground, short to V<sub>CC</sub> and OFF-state open-load.

A sense enable pin allows OFF-state diagnosis to be disabled during the module low-power mode as well as external sense resistor sharing among similar devices.

## 1 Block diagram and pin description

Figure 1. Block diagram

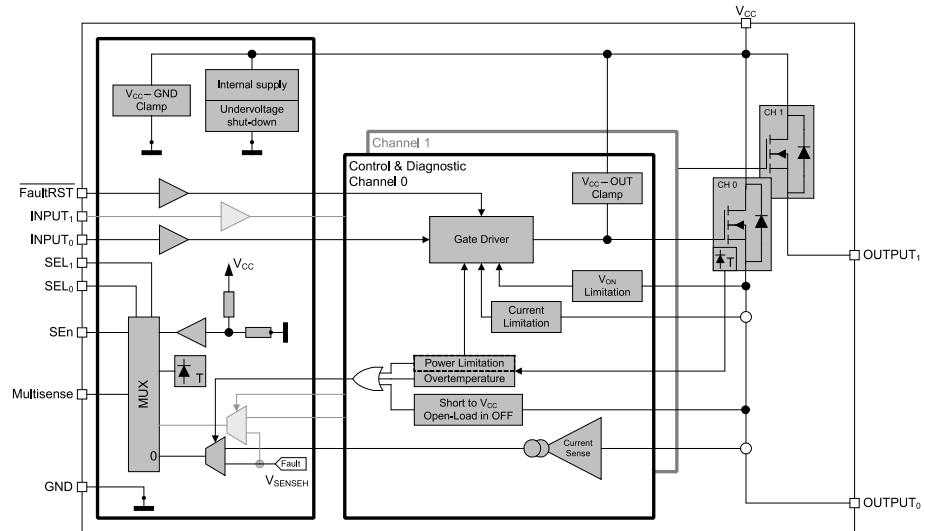


Table 1. Pin functions

| Name                  | Function                                                                                                                                               |
|-----------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------|
| VCC                   | Battery connection.                                                                                                                                    |
| OUTPUT <sub>0,1</sub> | Power output.                                                                                                                                          |
| GND                   | Ground connection. Must be reverse battery protected by an external diode / resistor network.                                                          |
| INPUT <sub>0,1</sub>  | Voltage controlled input pin with hysteresis, compatible with 3 V and 5 V CMOS outputs. It controls output switch state.                               |
| MultiSense            | Multiplexed analog sense output pin; it delivers a current proportional to the selected diagnostic: load current, supply voltage or chip temperature.  |
| SEn                   | Active high compatible with 3 V and 5 V CMOS outputs pin; it enables the MultiSense diagnostic pin.                                                    |
| SEL <sub>0,1</sub>    | Active high compatible with 3 V and 5 V CMOS outputs pin; they address the MultiSense multiplexer.                                                     |
| FaultRST              | Active low compatible with 3 V and 5 V CMOS outputs pin; it unlatches the output in case of fault; If kept low, sets the outputs in auto-restart. mode |

Figure 2. Block diagram and pin description

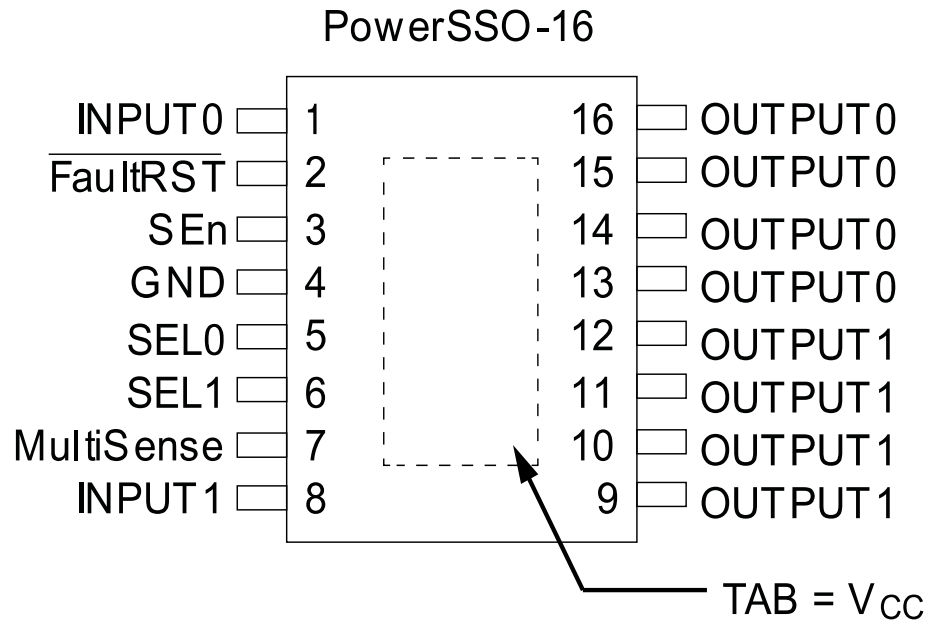


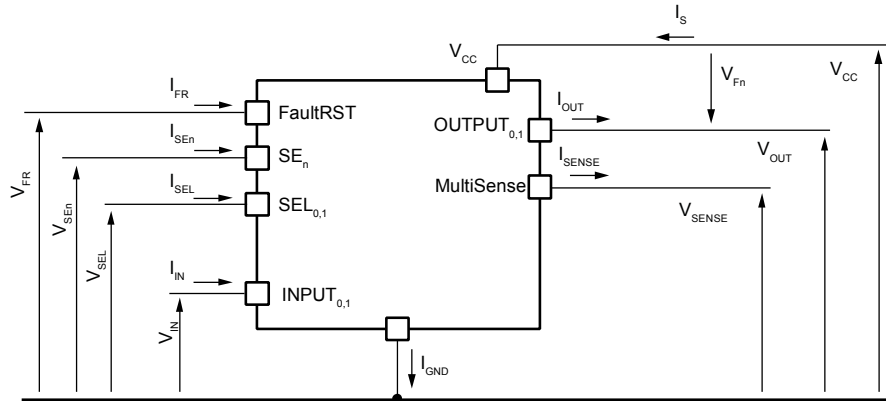
Table 2. Suggested connections for unused and not connected pins

| Connection / pin | MultiSense            | N.C.             | Output      | Input                  | SEn, SELx, FaultRST    |
|------------------|-----------------------|------------------|-------------|------------------------|------------------------|
| Floating         | Not allowed           | X <sup>(1)</sup> | X           | X                      | X                      |
| To ground        | Through 1 kΩ resistor | X                | Not allowed | Through 15 kΩ resistor | Through 15 kΩ resistor |

1. X: do not care.

## 2 Electrical specification

**Figure 3. Current and voltage conventions**



*Note:*  $V_{Fn} = O_{UTn} - V_{CC}$  during reverse battery condition.

**Table 3. Suggested connections for unused and not connected pins**

| Connction/pin | MultiSense            | N.C.             | Output      | Input                  | SEn, SELx, FaultRST    |
|---------------|-----------------------|------------------|-------------|------------------------|------------------------|
| Floating      | Not allowed           | X <sup>(1)</sup> | X           | X                      | X                      |
| To ground     | Through 1 kΩ resistor | X                | Not allowed | Through 15 kΩ resistor | Through 15 kΩ resistor |

1. X: do not care.

### 2.1 Absolute maximum ratings

Stressing the device above the rating listed in Table 4 may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to the conditions in table below for extended periods may affect device reliability.

**Table 4. Absolute maximum ratings**

| Symbol     | Parameter                                                                                    | Value              | Unit |
|------------|----------------------------------------------------------------------------------------------|--------------------|------|
| $V_{CC}$   | DC supply voltage                                                                            | 38                 | V    |
| $-V_{CC}$  | Reverse DC supply voltage                                                                    | 0.3                |      |
| $V_{CCPK}$ | Maximum transient supply voltage (ISO 16750-2:2010 Test B clamped to 40V; $R_L = 4 \Omega$ ) | 40                 | V    |
| $V_{CCJS}$ | Maximum jump start voltage for single pulse short circuit protection                         | 28                 | V    |
| $-I_{GND}$ | DC reverse ground pin current                                                                | 200                | mA   |
| $I_{OUT}$  | OUTPUT <sub>0,1</sub> DC output current                                                      | Internally limited | A    |
| $-I_{OUT}$ | Reverse DC output current                                                                    | 17                 |      |
| $I_{IN}$   | INPUT <sub>0,1</sub> DC input current                                                        | -1 to 10           | mA   |
| $I_{SEn}$  | SEn DC input current                                                                         |                    |      |

| Symbol      | Parameter                                                                                                                                                   | Value      | Unit |
|-------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------|------------|------|
| $I_{SEL}$   | SEL <sub>0,1</sub> DC input current                                                                                                                         | -1 to 10   | mA   |
| $I_{FR}$    | FaultRST DC input current                                                                                                                                   |            |      |
| $V_{FR}$    | FaultRST DC input voltage                                                                                                                                   | 7.5        | V    |
| $I_{SENSE}$ | MultiSense pin DC output current ( $V_{GND} = V_{CC}$ and $V_{SENSE} < 0$ V)                                                                                | 10         | mA   |
|             | MultiSense pin DC output current in reverse ( $V_{CC} < 0$ V)                                                                                               | -20        |      |
| $E_{MAX}$   | Maximum switching energy (single pulse) ( $T_{DEMAG} = 0.4$ ms; $T_{jstart} = 150$ °C)                                                                      | 64         | mJ   |
| $V_{ESD}$   | Electrostatic discharge (JEDEC 22A-114F)<br>• INPUT <sub>0,1</sub><br>• MultiSense<br>• SEn, SEL <sub>0,1</sub> , FaultRST<br>• OUTPUT <sub>0,1</sub> □ VCC | 4000       | V    |
|             |                                                                                                                                                             | 2000       | V    |
|             |                                                                                                                                                             | 4000       | V    |
|             |                                                                                                                                                             | 4000       | V    |
|             |                                                                                                                                                             | 4000       | V    |
| $V_{ESD}$   | Charge device model (CDM-AEC-Q100-011)                                                                                                                      | 750        | V    |
| $T_j$       | Junction operating temperature                                                                                                                              | -40 to 150 | °C   |
| $T_{stg}$   | Storage temperature                                                                                                                                         | -55 to 150 |      |

## 2.2 Thermal data

**Table 5. Thermal data**

| Symbol          | Parameter                                                                    | Typ. value | Unit |
|-----------------|------------------------------------------------------------------------------|------------|------|
| $R_{thj-board}$ | Thermal resistance junction-board (JEDEC JESD 51-5 / 51-8) <sup>(1)(2)</sup> | 4.9        | °C/W |
| $R_{thj-amb}$   | Thermal resistance junction-ambient (JEDEC JESD 51-5) <sup>(1)(3)</sup>      | 55.5       |      |
| $R_{thj-amb}$   | Thermal resistance junction-ambient (JEDEC JESD 51-7) <sup>(1)(2)</sup>      | 21.5       |      |

1. One channel ON.
2. Device mounted on four-layers 2s2p PCB
3. Device mounted on two-layers 2s0p PCB with 2 cm<sup>2</sup> heatsink copper trace

## 2.3 Main electrical characteristics

7 V <  $V_{CC}$  < 28 V; -40°C <  $T_j$  < 150°C, unless otherwise specified.

All typical values refer to  $V_{CC} = 13$  V;  $T_j = 25$ °C, unless otherwise specified.

**Table 6. Power section**

| Symbol         | Parameter                          | Test conditions                                | Min. | Typ. | Max. | Unit |
|----------------|------------------------------------|------------------------------------------------|------|------|------|------|
| $V_{CC}$       | Operating supply voltage           |                                                | 4    | 13   | 28   | V    |
| $V_{USD}$      | Undervoltage shutdown              |                                                |      |      | 4    | V    |
| $V_{USDReset}$ | Undervoltage shutdown reset        |                                                |      |      | 5    | V    |
| $V_{USDhyst}$  | Undervoltage shutdown hysteresis   |                                                |      | 0.3  |      | V    |
| $R_{ON}$       | On-state resistance <sup>(1)</sup> | $I_{OUT} = 3$ A; $T_j = 25$ °C                 |      | 22   |      | mΩ   |
|                |                                    | $I_{OUT} = 3$ A; $T_j = 150$ °C                |      |      | 44   |      |
|                |                                    | $I_{OUT} = 3$ A; $V_{CC} = 4$ V; $T_j = 25$ °C |      |      | 30   |      |

| Symbol               | Parameter                                                                  | Test conditions                                                                                                                                                                                                                                   | Min. | Typ. | Max. | Unit          |
|----------------------|----------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|---------------|
| $V_{\text{clamp}}$   | Clamp voltage                                                              | $I_S = 20 \text{ mA}; 25^\circ\text{C} < T_j < 150^\circ\text{C}$                                                                                                                                                                                 | 41   | 46   | 52   | V             |
|                      |                                                                            | $I_S = 20 \text{ mA}; T_j = -40^\circ\text{C}$                                                                                                                                                                                                    | 38   |      |      | V             |
| $I_{\text{STBY}}$    | Supply current in standby at $V_{\text{CC}} = 13 \text{ V}$ <sup>(2)</sup> | $V_{\text{CC}} = 13 \text{ V};$<br>$V_{\text{IN}} = V_{\text{OUT}} = V_{\text{FR}} = V_{\text{SEn}} = 0 \text{ V};$<br>$V_{\text{SEL0,1}} = 0 \text{ V}; T_j = 25^\circ\text{C}$                                                                  |      |      | 0.5  | $\mu\text{A}$ |
|                      |                                                                            | $V_{\text{CC}} = 13 \text{ V};$<br>$V_{\text{IN}} = V_{\text{OUT}} = V_{\text{FR}} = V_{\text{SEn}} = 0 \text{ V};$<br>$V_{\text{SEL0,1}} = 0 \text{ V}; T_j = 85^\circ\text{C}$ <sup>(3)</sup>                                                   |      |      | 0.5  |               |
|                      |                                                                            | $V_{\text{CC}} = 13 \text{ V};$<br>$V_{\text{IN}} = V_{\text{OUT}} = V_{\text{FR}} = V_{\text{SEn}} = 0 \text{ V};$<br>$V_{\text{SEL0,1}} = 0 \text{ V}; T_j = 125^\circ\text{C}$                                                                 |      |      | 3    |               |
| $t_{\text{D\_STBY}}$ | Standby mode blanking time                                                 | $V_{\text{CC}} = 13 \text{ V}$<br>$V_{\text{IN}} = V_{\text{OUT}} = V_{\text{FR}} = V_{\text{SEL0,1}} = 0 \text{ V};$<br>$V_{\text{SEn}} = 5 \text{ V to } 0 \text{ V}$                                                                           | 60   | 300  | 550  | $\mu\text{s}$ |
| $I_{\text{S(ON)}}$   | Supply current                                                             | $V_{\text{CC}} = 13 \text{ V}; V_{\text{SEn}} = V_{\text{FR}} = V_{\text{SEL0,1}} = 0 \text{ V};$<br>$V_{\text{IN0}} = 5 \text{ V}; V_{\text{IN1}} = 5 \text{ V};$<br>$I_{\text{OUT0}} = 0 \text{ A}; I_{\text{OUT1}} = 0 \text{ A}$              |      | 5    | 8    | mA            |
| $I_{\text{GND(ON)}}$ | Control stage current consumption in ON state. All channels active.        | $V_{\text{CC}} = 13 \text{ V}; V_{\text{SEn}} = 5 \text{ V};$<br>$V_{\text{FR}} = V_{\text{SEL0,1}} = 0 \text{ V}; V_{\text{IN0}} = 5 \text{ V};$<br>$V_{\text{IN1}} = 5 \text{ V}; I_{\text{OUT0}} = 3 \text{ A}; I_{\text{OUT1}} = 3 \text{ A}$ |      |      | 12   | mA            |
| $I_{\text{L(off)}}$  | Off-state output current at $V_{\text{CC}} = 13 \text{ V}$ <sup>(1)</sup>  | $V_{\text{IN}} = V_{\text{OUT}} = 0 \text{ V}; V_{\text{CC}} = 13 \text{ V}; T_j = 25^\circ\text{C}$                                                                                                                                              | 0    | 0.01 | 0.5  | $\mu\text{A}$ |
|                      |                                                                            | $V_{\text{IN}} = V_{\text{OUT}} = 0 \text{ V}; V_{\text{CC}} = 13 \text{ V}; T_j = 125^\circ\text{C}$                                                                                                                                             | 0    |      | 3    |               |
| $V_{\text{F}}$       | Output - $V_{\text{CC}}$ diode voltage <sup>(1)</sup>                      | $I_{\text{OUT}} = -3 \text{ A}; T_j = 150^\circ\text{C}$                                                                                                                                                                                          |      |      | 0.7  | V             |

1. For each channel
2. PowerMOS leakage included.
3. Parameter specified by design; not subject to production test.

**Table 7. Switching**

| $V_{\text{CC}} = 13 \text{ V}; -40^\circ\text{C} < T_j < 150^\circ\text{C}$ , unless otherwise specified |                                                               |                    |      |      |                     |                  |
|----------------------------------------------------------------------------------------------------------|---------------------------------------------------------------|--------------------|------|------|---------------------|------------------|
| Symbol                                                                                                   | Parameter                                                     | Test conditions    | Min. | Typ. | Max.                | Unit             |
| $t_{\text{d(on)}}^{(1)}$                                                                                 | Turn-on delay time at $T_j = 25^\circ\text{C}$                | $R_L = 4.3 \Omega$ | 10   | 60   | 120                 | $\mu\text{s}$    |
| $t_{\text{d(off)}}^{(1)}$                                                                                | Turn-off delay time at $T_j = 25^\circ\text{C}$               |                    | 10   | 40   | 100                 |                  |
| $(\text{dVOUT}/\text{dt})_{\text{on}}^{(1)}$                                                             | Turn-on voltage slope at $T_j = 25^\circ\text{C}$             | $R_L = 4.3 \Omega$ | 0.1  | 0.36 | 0.7                 | V/ $\mu\text{s}$ |
| $(\text{dVOUT}/\text{dt})_{\text{off}}^{(1)}$                                                            | Turn-off voltage slope at $T_j = 25^\circ\text{C}$            |                    | 0.1  | 0.36 | 0.7                 |                  |
| $W_{\text{ON}}$                                                                                          | Switching energy losses at turn-on ( $t_{\text{won}}$ )       | $R_L = 4.3 \Omega$ | —    | 0.38 | 0.49 <sup>(2)</sup> | mJ               |
| $W_{\text{OFF}}$                                                                                         | Switching energy losses at turn-off ( $t_{\text{woff}}$ )     | $R_L = 4.3 \Omega$ | —    | 0.39 | 0.54 <sup>(2)</sup> | mJ               |
| $t_{\text{SKEW}}^{(1)}$                                                                                  | Differential Pulse skew ( $t_{\text{PHL}} - t_{\text{PLH}}$ ) | $R_L = 4.3 \Omega$ | -75  | -25  | 25                  | $\mu\text{s}$    |

1. See Figure 6: "Switching time and Pulse skew"

2. Parameter guaranteed by design and characterization; not subject to production test.

**Table 8. Logic inputs**

| 7 V < V <sub>CC</sub> < 28 V; -40°C < T <sub>j</sub> < 150°C      |                          |                         |      |      |      |      |
|-------------------------------------------------------------------|--------------------------|-------------------------|------|------|------|------|
| Symbol                                                            | Parameter                | Test conditions         | Min. | Typ. | Max. | Unit |
| INPUT <sub>0,1</sub> characteristics                              |                          |                         |      |      |      |      |
| V <sub>IL</sub>                                                   | Input low level voltage  |                         |      |      | 0.9  | V    |
| I <sub>IL</sub>                                                   | Low level input current  | V <sub>IN</sub> = 0.9 V | 1    |      |      | μA   |
| V <sub>IH</sub>                                                   | Input high level voltage |                         | 2.1  |      |      | V    |
| I <sub>IH</sub>                                                   | High level input current | V <sub>IN</sub> = 2.1 V |      |      | 10   | μA   |
| V <sub>I(hyst)</sub>                                              | Input hysteresis voltage |                         | 0.2  |      |      | V    |
| V <sub>ICL</sub>                                                  | Input clamp voltage      | I <sub>IN</sub> = 1 mA  | 5.3  |      | 7.2  | V    |
|                                                                   |                          | I <sub>IN</sub> = -1 mA |      | -0.7 |      |      |
| FaultRST characteristics                                          |                          |                         |      |      |      |      |
| V <sub>FRL</sub>                                                  | Input low level voltage  |                         |      |      | 0.9  | V    |
| I <sub>FRL</sub>                                                  | Low level input current  | V <sub>IN</sub> = 0.9 V | 1    |      |      | μA   |
| V <sub>FRH</sub>                                                  | Input high level voltage |                         | 2.1  |      |      | V    |
| I <sub>FRH</sub>                                                  | High level input current | V <sub>IN</sub> = 2.1 V |      |      | 10   | μA   |
| V <sub>FR(hyst)</sub>                                             | Input hysteresis voltage |                         | 0.2  |      |      | V    |
| V <sub>FRCL</sub>                                                 | Input clamp voltage      | I <sub>IN</sub> = 1 mA  | 5.3  |      | 7.5  | V    |
|                                                                   |                          | I <sub>IN</sub> = -1 mA |      | -0.7 |      |      |
| SEL <sub>0,1</sub> characteristics (7 V < V <sub>CC</sub> < 18 V) |                          |                         |      |      |      |      |
| V <sub>SELL</sub>                                                 | Input low level voltage  |                         |      |      | 0.9  | V    |
| I <sub>SELL</sub>                                                 | Low level input current  | V <sub>IN</sub> = 0.9 V | 1    |      |      | μA   |
| V <sub>SELH</sub>                                                 | Input high level voltage |                         | 2.1  |      |      | V    |
| I <sub>SELH</sub>                                                 | High level input current | V <sub>IN</sub> = 2.1 V |      |      | 10   | μA   |
| V <sub>SEL(hyst)</sub>                                            | Input hysteresis voltage |                         | 0.2  |      |      | V    |
| V <sub>SELCL</sub>                                                | Input clamp voltage      | I <sub>IN</sub> = 1 mA  | 5.3  |      | 7.2  | V    |
|                                                                   |                          | I <sub>IN</sub> = -1 mA |      | -0.7 |      |      |
| SEn characteristics (7 V < V <sub>CC</sub> < 18 V)                |                          |                         |      |      |      |      |
| V <sub>SEnL</sub>                                                 | Input low level voltage  |                         |      |      | 0.9  | V    |
| I <sub>SEnL</sub>                                                 | Low level input current  | V <sub>IN</sub> = 0.9 V | 1    |      |      | μA   |
| V <sub>SEnH</sub>                                                 | Input high level voltage |                         | 2.1  |      |      | V    |
| I <sub>SEnH</sub>                                                 | High level input current | V <sub>IN</sub> = 2.1 V |      |      | 10   | μA   |
| V <sub>SEn(hyst)</sub>                                            | Input hysteresis voltage |                         | 0.2  |      |      | V    |
| V <sub>SEnCL</sub>                                                | Input clamp voltage      | I <sub>IN</sub> = 1 mA  | 5.3  |      | 7.2  | V    |
|                                                                   |                          | I <sub>IN</sub> = -1 mA |      | -0.7 |      |      |

**Table 9. Protections**

| 7 V < V <sub>CC</sub> < 18 V; -40°C < T <sub>j</sub> < 150°C |                                                    |                                                                                                                                                                     |                     |                     |                    |      |
|--------------------------------------------------------------|----------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------|---------------------|--------------------|------|
| Symbol                                                       | Parameter                                          | Test conditions                                                                                                                                                     | Min.                | Typ.                | Max.               | Unit |
| I <sub>LIMH</sub>                                            | DC short circuit current                           | V <sub>CC</sub> = 13 V                                                                                                                                              | 45                  | 63                  | 90                 | A    |
|                                                              |                                                    | 4 V < V <sub>CC</sub> < 18 V <sup>(1)</sup>                                                                                                                         |                     |                     |                    |      |
| I <sub>LIML</sub>                                            | Short circuit current during thermal cycling       | V <sub>CC</sub> = 13 V; T <sub>R</sub> < T <sub>j</sub> < T <sub>TSD</sub>                                                                                          |                     | 23                  |                    |      |
| T <sub>TSD</sub>                                             | Shutdown temperature                               |                                                                                                                                                                     | 150                 | 175                 | 200                | °C   |
| T <sub>R</sub>                                               | Reset temperature <sup>(1)</sup>                   |                                                                                                                                                                     | T <sub>RS</sub> + 1 | T <sub>RS</sub> + 7 |                    |      |
| T <sub>RS</sub>                                              | Thermal reset of fault diagnostic indication       | V <sub>FR</sub> = 0 V; V <sub>SEn</sub> = 5 V                                                                                                                       | 135                 |                     |                    |      |
| T <sub>HYST</sub>                                            | Thermal hysteresis (TTSD - TR) <sup>(1)</sup>      |                                                                                                                                                                     |                     | 7                   |                    |      |
| ΔT <sub>J_SD</sub>                                           | Dynamic temperature                                | T <sub>j</sub> = -40°C; V <sub>CC</sub> = 13 V                                                                                                                      |                     | 60                  |                    | K    |
| t <sub>LATCH_RST</sub>                                       | Fault reset time for output unlatch <sup>(1)</sup> | V <sub>FR</sub> = 5 V to 0 V; V <sub>SEn</sub> = 5 V;<br>□ E.g. Ch <sub>0</sub> :<br>V <sub>IN0</sub> = 5 V;<br>V <sub>SEL0</sub> = 0 V;<br>V <sub>SEL1</sub> = 0 V | 3                   | 10                  | 20                 | μs   |
| V <sub>DEMAG</sub>                                           | Turn-off output voltage clamp                      | I <sub>OUT</sub> = 2 A; L = 6 mH; T <sub>j</sub> = -40°C                                                                                                            | V <sub>CC</sub> 38  |                     |                    | V    |
|                                                              |                                                    | I <sub>OUT</sub> = 2 A; L = 6 mH; T <sub>j</sub> = 25°C to 150°C                                                                                                    | V <sub>CC</sub> 41  | V <sub>CC</sub> 46  | V <sub>CC</sub> 52 | V    |
| V <sub>ON</sub>                                              | Output voltage drop limitation                     | I <sub>OUT</sub> = 0.5 A                                                                                                                                            |                     | 20                  |                    | mV   |

1. Parameter guaranteed by design and characterization; not subject to production test.

**Table 10. MultiSense**

| 7 V < V <sub>CC</sub> < 18 V; -40°C < T <sub>j</sub> < 150°C |                                                |                                                                                                                         |      |      |      |      |
|--------------------------------------------------------------|------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------|------|------|------|------|
| Symbol                                                       | Parameter                                      | Test conditions                                                                                                         | Min. | Typ. | Max. | Unit |
| V <sub>SENSE_CL</sub>                                        | MultiSense clamp voltage                       | V <sub>SEn</sub> = 0 V; I <sub>SENSE</sub> = 1 mA                                                                       | -17  |      | -12  | V    |
|                                                              |                                                | V <sub>SEn</sub> = 0 V; I <sub>SENSE</sub> = -1 mA                                                                      |      | 7    |      |      |
| Current sense characteristics                                |                                                |                                                                                                                         |      |      |      |      |
| K <sub>OL</sub>                                              | I <sub>OUT</sub> /I <sub>SENSE</sub>           | I <sub>OUT</sub> = 0.01 A;<br>V <sub>SENSE</sub> = 0.5 V; V <sub>SEn</sub> = 5 V                                        | 1020 |      |      |      |
| dK <sub>cal</sub> /K <sub>cal</sub> <sup>(1)(2)</sup>        | Current sense ratio drift at calibration point | I <sub>OUT</sub> = 0.01 A to 0.05 A;<br>I <sub>cal</sub> = 30 mA; V <sub>SENSE</sub> = 0.5 V;<br>V <sub>SEn</sub> = 5 V | -30  |      | 30   | %    |
| K <sub>LED</sub>                                             | I <sub>OUT</sub> /I <sub>SENSE</sub>           | I <sub>OUT</sub> = 0.1 A; V <sub>SENSE</sub> = 0.5 V; V <sub>SEn</sub> = 5 V                                            | 1800 | 3450 | 5100 |      |
| dK <sub>LED</sub> /K <sub>LED</sub> <sup>(1)(2)</sup>        | Current sense ratio drift                      | I <sub>OUT</sub> = 0.1 A; V <sub>SENSE</sub> = 0.5 V; V <sub>SEn</sub> = 5 V                                            | -25  |      | 25   | %    |
| K <sub>0</sub>                                               | I <sub>OUT</sub> /I <sub>SENSE</sub>           | I <sub>OUT</sub> = 0.5 A; V <sub>SENSE</sub> = 0.5 V; V <sub>SEn</sub> = 5 V                                            | 2120 | 3020 | 3915 |      |



| 7 V < V <sub>CC</sub> < 18 V; -40°C < T <sub>j</sub> < 150°C |                                                        |                                                                                                                                                                                                                                                                                                                          |                                    |      |                              |                            |
|--------------------------------------------------------------|--------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------|------|------------------------------|----------------------------|
| Symbol                                                       | Parameter                                              | Test conditions                                                                                                                                                                                                                                                                                                          | Min.                               | Typ. | Max.                         | Unit                       |
| dK <sub>0</sub> /K <sub>0</sub> <sup>(1)(2)</sup>            | Current sense ratio drift                              | I <sub>OUT</sub> = 0.5 A; V <sub>SENSE</sub> = 0.5 V; V <sub>SEn</sub> = 5 V                                                                                                                                                                                                                                             | -20                                |      | 20                           | %                          |
| K <sub>1</sub>                                               | I <sub>OUT</sub> /I <sub>SENSE</sub>                   | I <sub>OUT</sub> = 1 A; V <sub>SENSE</sub> = 4 V; V <sub>SEn</sub> = 5 V                                                                                                                                                                                                                                                 | 2060                               | 2875 | 3690                         |                            |
| dK <sub>1</sub> /K <sub>1</sub> <sup>(1)(2)</sup>            | Current sense ratio drift                              | I <sub>OUT</sub> = 1 A; V <sub>SENSE</sub> = 4 V; V <sub>SEn</sub> = 5 V                                                                                                                                                                                                                                                 | -15                                |      | 15                           | %                          |
| K <sub>2</sub>                                               | I <sub>OUT</sub> /I <sub>SENSE</sub>                   | I <sub>OUT</sub> = 3 A; V <sub>SENSE</sub> = 4 V; V <sub>SEn</sub> = 5 V                                                                                                                                                                                                                                                 | 2340                               | 2755 | 3170                         |                            |
| dK <sub>2</sub> /K <sub>2</sub> <sup>(1)(2)</sup>            | Current sense ratio drift                              | I <sub>OUT</sub> = 3 A; V <sub>SENSE</sub> = 4 V; V <sub>SEn</sub> = 5 V                                                                                                                                                                                                                                                 | -6                                 |      | 6                            | %                          |
| K <sub>3</sub>                                               | I <sub>OUT</sub> /I <sub>SENSE</sub>                   | I <sub>OUT</sub> = 9 A; V <sub>SENSE</sub> = 4 V; V <sub>SEn</sub> = 5 V                                                                                                                                                                                                                                                 | 2550                               | 2740 | 2950                         |                            |
| dK <sub>3</sub> /K <sub>3</sub> <sup>(1)(2)</sup>            | Current sense ratio drift                              | I <sub>OUT</sub> = 9 A; V <sub>SENSE</sub> = 4 V; V <sub>SEn</sub> = 5 V                                                                                                                                                                                                                                                 | -5                                 |      | 5                            | %                          |
| dK/K <sub>(tot)</sub> <sup>(1)(3)</sup>                      | Current sense ratio drift for single point calibration | Calibration point:<br>I <sub>cal</sub> = 2.4 A; T <sub>j</sub> = 25°C;<br>V <sub>CC</sub> = 13 V<br>I <sub>OUT</sub> = 0.5 A<br>I <sub>OUT</sub> = 1.5 A<br>I <sub>OUT</sub> = 2.0 A<br>I <sub>OUT</sub> = 2.4 A<br>I <sub>OUT</sub> = 3.0 A<br>I <sub>OUT</sub> = 4.0 A                                                 | -30<br>-13<br>-7<br>-6<br>-7<br>-8 |      | 30<br>13<br>7<br>6<br>7<br>8 | %<br>%<br>%<br>%<br>%<br>% |
| V <sub>OUT_MSD</sub> <sup>(1)</sup>                          | Output Voltage for MultiSense shutdown                 | V <sub>SEn</sub> = 5 V; R <sub>SENSE</sub> = 2.7 kΩ;<br>□ E.g. Ch <sub>0</sub> :<br>V <sub>IN0</sub> = 5 V;<br>V <sub>SEL0</sub> = 0 V;<br>V <sub>SEL1</sub> = 0 V; I <sub>OUT0</sub> = 3 A                                                                                                                              |                                    | 5    |                              | V                          |
| I <sub>SENSE0</sub>                                          | MultiSense leakage current                             | MultiSense disabled: V <sub>SEn</sub> = 0 V                                                                                                                                                                                                                                                                              | 0                                  |      | 0.5                          | μA                         |
|                                                              |                                                        | MultiSense disabled:<br>-1 V < V <sub>SENSE</sub> < 5 V <sup>(1)</sup>                                                                                                                                                                                                                                                   | -0.5                               |      | 0.5                          |                            |
|                                                              |                                                        | MultiSense enabled:<br>V <sub>SEn</sub> = 5 V; All channels ON; I <sub>OUTX</sub> = 0 A; Ch <sub>X</sub> diagnostic selected;<br>• E.g. Ch <sub>0</sub> :<br>V <sub>IN0</sub> = 5 V; V <sub>IN1</sub> = 5 V;<br>V <sub>SEL0</sub> = 0 V;<br>V <sub>SEL1</sub> = 0 V;<br>I <sub>OUT0</sub> = 0 A; I <sub>OUT1</sub> = 3 A | 0                                  |      | 2                            |                            |
|                                                              |                                                        | MultiSense enabled:<br>V <sub>SEn</sub> = 5 V; Ch <sub>X</sub> OFF; Ch <sub>X</sub> diagnostic selected:                                                                                                                                                                                                                 | 0                                  |      | 2                            |                            |

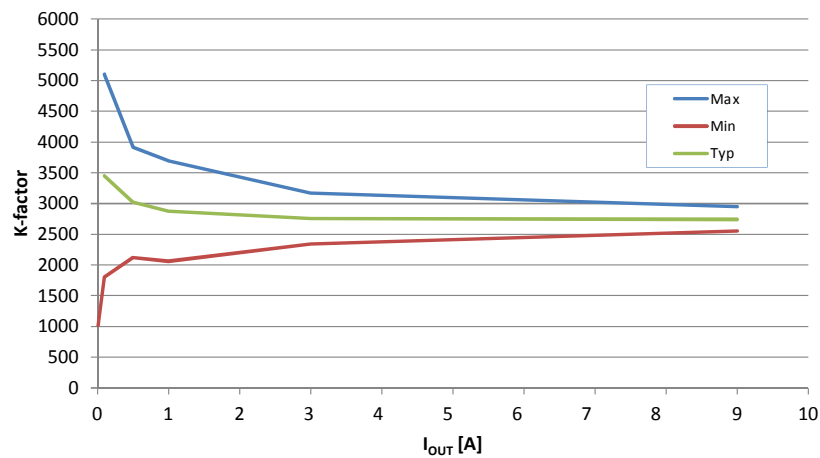
| 7 V < V <sub>CC</sub> < 18 V; -40°C < T <sub>j</sub> < 150°C |                                                                                           |                                                                                                                                                                                                                                                                                                                        |      |      |      |      |
|--------------------------------------------------------------|-------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|------|
| Symbol                                                       | Parameter                                                                                 | Test conditions                                                                                                                                                                                                                                                                                                        | Min. | Typ. | Max. | Unit |
| I <sub>SENSE0</sub>                                          | MultiSense leakage current                                                                | <ul style="list-style-type: none"> <li>E.g. Ch<sub>0</sub>:<br/>V<sub>IN0</sub> = 0 V; V<sub>IN1</sub> = 5 V;<br/>V<sub>SEL0</sub> = 0 V;<br/>V<sub>SEL1</sub> = 0 V;<br/>I<sub>OUT1</sub> = 3 A</li> </ul>                                                                                                            |      |      |      | μA   |
| V <sub>SENSE_SAT</sub>                                       | Multisense saturation voltage                                                             | V <sub>CC</sub> = 7 V; R <sub>SENSE</sub> = 2.7 kΩ;<br>V <sub>SEn</sub> = 5 V; V <sub>IN0</sub> = 5 V;<br>V <sub>SEL0</sub> = 0 V; V <sub>SEL1</sub> = 0 V;<br>I <sub>OUT0</sub> = 9 A; T <sub>j</sub> = 150°C                                                                                                         | 5    |      |      | V    |
| I <sub>SENSE_SAT</sub> <sup>(1)</sup>                        | CS saturation current                                                                     | V <sub>CC</sub> = 7 V; V <sub>SENSE</sub> = 4 V;<br>V <sub>IN0</sub> = 5 V; V <sub>SEn</sub> = 5 V;<br>V <sub>SEL0</sub> = 0 V; V <sub>SEL1</sub> = 0 V;<br>T <sub>j</sub> = 150°C                                                                                                                                     | 4    |      |      | mA   |
| I <sub>OUT_SAT</sub> <sup>(1)</sup>                          | Output saturation current                                                                 | V <sub>CC</sub> = 7 V; V <sub>SENSE</sub> = 4 V;<br>V <sub>IN0</sub> = 5 V; V <sub>SEn</sub> = 5 V;<br>V <sub>SEL0</sub> = 0 V; V <sub>SEL1</sub> = 0 V;<br>T <sub>j</sub> = 150°C                                                                                                                                     | 11.5 |      |      | A    |
| <b>OFF-state diagnostic</b>                                  |                                                                                           |                                                                                                                                                                                                                                                                                                                        |      |      |      |      |
| V <sub>OL</sub>                                              | OFF-state openload voltage detection threshold                                            | V <sub>SEn</sub> = 5 V; Ch <sub>X</sub> OFF;<br>Ch <sub>X</sub> diagnostic selected <ul style="list-style-type: none"> <li>E.g: Ch<sub>0</sub><br/>V<sub>IN0</sub> = 0 V;<br/>V<sub>SEL0</sub> = 0 V;<br/>V<sub>SEL1</sub> = 0 V</li> </ul>                                                                            | 2    | 3    | 4    | V    |
| I <sub>L(off2)</sub>                                         | OFF-state output sink current                                                             | V <sub>IN</sub> = 0 V; V <sub>OUT</sub> = V <sub>OL</sub> ; T <sub>j</sub> = 40°C to 125°C                                                                                                                                                                                                                             | -100 |      | -15  | μA   |
| t <sub>DSTKON</sub>                                          | OFF-state diagnostic delay time from falling edge of INPUT (see Figure 9)                 | V <sub>SEn</sub> = 5 V; Ch <sub>X</sub> ON to OFF transition;<br>Ch <sub>X</sub> diagnostic selected <ul style="list-style-type: none"> <li>E.g: Ch<sub>0</sub><br/>V<sub>IN0</sub> = 5 V to 0 V;<br/>V<sub>SEL0</sub> = 0 V;<br/>V<sub>SEL1</sub> = 0 V;<br/>I<sub>OUT0</sub> = 0 A; V<sub>OUT</sub> = 4 V</li> </ul> | 100  | 350  | 700  | μs   |
| t <sub>D_OL_V</sub>                                          | Settling time for valid OFF-state open load diagnostic indication from rising edge of SEn | V <sub>IN0</sub> = 0 V; V <sub>IN1</sub> = 0 V;<br>V <sub>FR</sub> = 0 V; V <sub>SEL0</sub> = 0 V;<br>V <sub>SEL1</sub> = 0 V; V <sub>OUT0</sub> = 4 V;<br>V <sub>SEn</sub> = 0 V to 5 V                                                                                                                               |      |      | 60   | μs   |
| t <sub>D_VOL</sub>                                           | OFF-state diagnostic delay time from rising edge of V <sub>OUT</sub>                      | V <sub>SEn</sub> = 5 V; Ch <sub>X</sub> OFF;<br>Ch <sub>X</sub> diagnostic selected <ul style="list-style-type: none"> <li>E.g: Ch<sub>0</sub><br/>V<sub>IN0</sub> = 0 V;<br/>V<sub>SEL0</sub> = 0 V;<br/>V<sub>SEL1</sub> = 0 V;<br/>V<sub>OUT</sub> = 0 V to 4 V</li> </ul>                                          |      | 5    | 30   | μs   |

| 7 V < V <sub>CC</sub> < 18 V; -40°C < T <sub>j</sub> < 150°C |                                                                                                                           |                                                                                                                                                                                                                                                         |       |      |       |      |
|--------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------|------|-------|------|
| Symbol                                                       | Parameter                                                                                                                 | Test conditions                                                                                                                                                                                                                                         | Min.  | Typ. | Max.  | Unit |
| Chip temperature analog feedback                             |                                                                                                                           |                                                                                                                                                                                                                                                         |       |      |       |      |
| V <sub>SENSE_TC</sub>                                        | MultiSense output voltage proportional to chip temperature                                                                | V <sub>SEn</sub> = 5 V; V <sub>SEL0</sub> = 0 V;<br>V <sub>SEL1</sub> = 5 V; V <sub>IN0,1</sub> = 0 V;<br>R <sub>SENSE</sub> = 1 kΩ; T <sub>j</sub> = -40°C                                                                                             | 2.325 | 2.41 | 2.495 | V    |
|                                                              |                                                                                                                           | V <sub>SEn</sub> = 5 V; V <sub>SEL0</sub> = 0 V;<br>V <sub>SEL1</sub> = 5 V; V <sub>IN0,1</sub> = 0 V;<br>R <sub>SENSE</sub> = 1 kΩ; T <sub>j</sub> = 25°C                                                                                              | 1.985 | 2.07 | 2.155 | V    |
|                                                              |                                                                                                                           | V <sub>SEn</sub> = 5 V; V <sub>SEL0</sub> = 0 V;<br>V <sub>SEL1</sub> = 5 V; V <sub>IN0,1</sub> = 0 V;<br>R <sub>SENSE</sub> = 1 kΩ; T <sub>j</sub> = 125°C                                                                                             | 1.435 | 1.52 | 1.605 | V    |
| dV <sub>SENSE_TC</sub> /dT                                   | Temperature coefficient                                                                                                   | T <sub>j</sub> = -40°C to 150°C                                                                                                                                                                                                                         |       | -5.5 |       | mV/K |
| Transfer function                                            |                                                                                                                           | V <sub>SENSE_TC</sub> (T) = V <sub>SENSE_TC</sub> (T <sub>0</sub> ) + dV <sub>SENSE_TC</sub> / dT * (T - T <sub>0</sub> )                                                                                                                               |       |      |       |      |
| V <sub>CC</sub> supply voltage analog feedback               |                                                                                                                           |                                                                                                                                                                                                                                                         |       |      |       |      |
| V <sub>SENSE_VCC</sub>                                       | MultiSense output voltage proportional to V <sub>CC</sub> supply voltage                                                  | V <sub>CC</sub> = 13 V; V <sub>SEn</sub> = 5 V;<br>V <sub>SEL0</sub> = 5 V; V <sub>SEL1</sub> = 5 V;<br>V <sub>IN0,1</sub> = 0 V; R <sub>SENSE</sub> = 1 kΩ                                                                                             | 3.16  | 3.23 | 3.3   | V    |
| Transfer function <sup>(4)</sup>                             |                                                                                                                           | V <sub>SENSE_VCC</sub> = V <sub>CC</sub> / 4                                                                                                                                                                                                            |       |      |       |      |
| Fault diagnostic feedback (see Table 11)                     |                                                                                                                           |                                                                                                                                                                                                                                                         |       |      |       |      |
| V <sub>SENSEH</sub>                                          | MultiSense output voltage in fault condition                                                                              | V <sub>CC</sub> = 13 V; R <sub>SENSE</sub> = 1 kΩ;<br>• E.g: Ch <sub>0</sub> in open load<br>V <sub>IN0</sub> = 0 V; V <sub>SEn</sub> = 5 V;<br>V <sub>SEL0</sub> = 0 V;<br>V <sub>SEL1</sub> = 0 V;<br>I <sub>OUT0</sub> = 0 A; V <sub>OUT</sub> = 4 V | 5     |      | 6.6   | V    |
| I <sub>SENSEH</sub>                                          | MultiSense output current in fault condition                                                                              | V <sub>CC</sub> = 13 V; V <sub>SENSE</sub> = 5 V                                                                                                                                                                                                        | 7     | 20   | 30    | mA   |
| MultiSense timings (current sense mode - see Figure 7")      |                                                                                                                           |                                                                                                                                                                                                                                                         |       |      |       |      |
| t <sub>DSENSE1H</sub>                                        | Current sense settling time from rising edge of SEn                                                                       | V <sub>IN</sub> = 5 V; V <sub>SEn</sub> = 0 V to 5 V;<br>R <sub>SENSE</sub> = 1 kΩ; R <sub>L</sub> = 4.3 Ω                                                                                                                                              |       |      | 60    | μs   |
| t <sub>DSENSE1L</sub>                                        | Current sense disable delay time from falling edge of SEn                                                                 | V <sub>IN</sub> = 5 V; V <sub>SEn</sub> = 5 V to 0 V;<br>R <sub>SENSE</sub> = 1 kΩ; R <sub>L</sub> = 4.3 Ω                                                                                                                                              |       | 5    | 20    | μs   |
| t <sub>DSENSE2H</sub>                                        | Current sense settling time from rising edge of INPUT                                                                     | V <sub>IN</sub> = 0 V to 5 V; V <sub>SEn</sub> = 5 V;<br>R <sub>SENSE</sub> = 1 kΩ; R <sub>L</sub> = 4.3 Ω                                                                                                                                              |       | 100  | 250   | μs   |
| Δt <sub>DSENSE2H</sub>                                       | Current sense settling time from rising edge of I <sub>OUT</sub> (dynamic response to a step change of I <sub>OUT</sub> ) | V <sub>IN</sub> = 5 V; V <sub>SEn</sub> = 5 V;<br>R <sub>SENSE</sub> = 1 kΩ; I <sub>SENSE</sub> = 90 % of I <sub>SENSEMAX</sub> ;<br>R <sub>L</sub> = 4.3 Ω                                                                                             |       |      | 100   | μs   |
| t <sub>DSENSE2L</sub>                                        | Current sense turnoff delay time from falling edge of                                                                     | V <sub>IN</sub> = 5 V to 0 V; V <sub>SEn</sub> = 5 V;<br>R <sub>SENSE</sub> = 1 kΩ; R <sub>L</sub> = 4.3 Ω                                                                                                                                              |       | 50   | 250   | μs   |

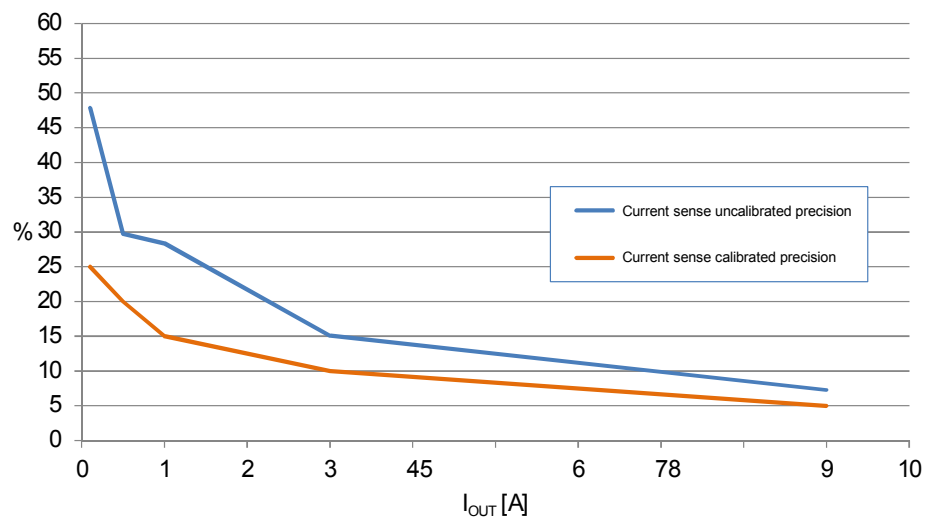
| 7 V < V <sub>CC</sub> < 18 V; -40°C < T <sub>j</sub> < 150°C                 |                                                                                |                                                                                                                                                                                                                       |      |      |      |      |
|------------------------------------------------------------------------------|--------------------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|------|
| Symbol                                                                       | Parameter                                                                      | Test conditions                                                                                                                                                                                                       | Min. | Typ. | Max. | Unit |
|                                                                              | INPUT                                                                          |                                                                                                                                                                                                                       |      |      |      |      |
| <b>MultiSense timings (chip temperature sense mode - see Figure 8)</b>       |                                                                                |                                                                                                                                                                                                                       |      |      |      |      |
| t <sub>DSENSE3H</sub>                                                        | V <sub>SENSE_TC</sub> settling time from rising edge of SEn                    | V <sub>SEn</sub> = 0 V to 5 V;<br>V <sub>SEL0</sub> = 0 V; V <sub>SEL1</sub> = 5 V;<br>R <sub>SENSE</sub> = 1 kΩ                                                                                                      |      |      | 60   | μs   |
| t <sub>DSENSE3L</sub>                                                        | V <sub>SENSE_TC</sub> disable delay time from falling edge of SEn              | V <sub>SEn</sub> = 5 V to 0 V;<br>V <sub>SEL0</sub> = 0 V; V <sub>SEL1</sub> = 5 V;<br>R <sub>SENSE</sub> = 1 kΩ                                                                                                      |      |      | 20   | μs   |
| <b>MultiSense timings (V<sub>CC</sub> voltage sense mode - see Figure 8)</b> |                                                                                |                                                                                                                                                                                                                       |      |      |      |      |
| t <sub>DSENSE4H</sub>                                                        | V <sub>SENSE_VCC</sub> settling time from rising edge of SEn                   | V <sub>SEn</sub> = 0 V to 5 V;<br>V <sub>SEL0</sub> = 5 V; V <sub>SEL1</sub> = 5 V;<br>R <sub>SENSE</sub> = 1 kΩ                                                                                                      |      |      | 60   | μs   |
| t <sub>DSENSE4L</sub>                                                        | V <sub>SENSE_VCC</sub> disable delay time from falling edge of SEn             | V <sub>SEn</sub> = 5 V to 0 V;<br>V <sub>SEL0</sub> = 5 V; V <sub>SEL1</sub> = 5 V;<br>R <sub>SENSE</sub> = 1 kΩ                                                                                                      |      |      | 20   | μs   |
| <b>MultiSense timings (Multiplexer transition times)<sup>(5)</sup></b>       |                                                                                |                                                                                                                                                                                                                       |      |      |      |      |
| t <sub>D_XtoY</sub>                                                          | MultiSense transition delay from Ch <sub>X</sub> to Ch <sub>Y</sub>            | V <sub>IN0</sub> = 5 V; V <sub>IN1</sub> = 5 V;<br>V <sub>SEn</sub> = 5 V; V <sub>SEL1</sub> = 0 V; V <sub>SEL0</sub> = 0 V to 5 V;<br>I <sub>OUT0</sub> = 0 A; I <sub>OUT1</sub> = 3 A;<br>R <sub>SENSE</sub> = 1 kΩ |      |      | 20   | μs   |
| t <sub>D_CStoTC</sub>                                                        | MultiSense transition delay from current sense to T <sub>C</sub> sense         | V <sub>IN0</sub> = 5 V; V <sub>SEn</sub> = 5 V;<br>V <sub>SEL0</sub> = 0 V; V <sub>SEL1</sub> = 0 V to 5 V; I <sub>OUT0</sub> = 1.5 A;<br>R <sub>SENSE</sub> = 1 kΩ                                                   |      |      | 60   | μs   |
| t <sub>D_TCtoCS</sub>                                                        | MultiSense transition delay from T <sub>C</sub> sense to current sense         | V <sub>IN0</sub> = 5 V; V <sub>SEn</sub> = 5 V;<br>V <sub>SEL0</sub> = 0 V; V <sub>SEL1</sub> = 5 V to 0 V; I <sub>OUT0</sub> = 1.5 A;<br>R <sub>SENSE</sub> = 1 kΩ                                                   |      |      | 20   | μs   |
| t <sub>D_CStoVCC</sub>                                                       | MultiSense transition delay from current sense to V <sub>CC</sub> sense        | V <sub>IN1</sub> = 5 V; V <sub>SEn</sub> = 5 V;<br>V <sub>SEL0</sub> = 5 V; V <sub>SEL1</sub> = 0 V to 5 V; I <sub>OUT1</sub> = 1.5 A;<br>R <sub>SENSE</sub> = 1 kΩ                                                   |      |      | 60   | μs   |
| t <sub>D_VCCtoCS</sub>                                                       | MultiSense transition delay from V <sub>CC</sub> sense to current sense        | V <sub>IN1</sub> = 5 V; V <sub>SEn</sub> = 5 V;<br>V <sub>SEL0</sub> = 5 V; V <sub>SEL1</sub> = 5 V to 0 V; I <sub>OUT1</sub> = 1.5 A;<br>R <sub>SENSE</sub> = 1 kΩ                                                   |      |      | 20   | μs   |
| t <sub>D_TCtoVCC</sub>                                                       | MultiSense transition delay from T <sub>C</sub> sense to V <sub>CC</sub> sense | V <sub>CC</sub> = 13 V; T <sub>j</sub> = 125°C;<br>V <sub>SEn</sub> = 5 V; V <sub>SEL0</sub> = 0 V to 5 V; V <sub>SEL1</sub> = 5 V;                                                                                   |      |      | 20   | μs   |

| 7 V < V <sub>CC</sub> < 18 V; -40°C < T <sub>j</sub> < 150°C |                                                                                                                    |                                                                                                                                                                                                                          |      |      |      |      |
|--------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|------|
| Symbol                                                       | Parameter                                                                                                          | Test conditions                                                                                                                                                                                                          | Min. | Typ. | Max. | Unit |
|                                                              |                                                                                                                    | R <sub>SENSE</sub> = 1 kΩ                                                                                                                                                                                                |      |      |      |      |
| t <sub>D_VCCtoTC</sub>                                       | MultiSense transition delay from V <sub>CC</sub> sense to T <sub>C</sub> sense                                     | V <sub>CC</sub> = 13 V; T <sub>j</sub> = 125°C;<br>V <sub>SEN</sub> = 5 V; V <sub>SEL0</sub> = 5 V to 0 V; V <sub>SEL1</sub> = 5 V;<br>R <sub>SENSE</sub> = 1 kΩ                                                         |      |      | 20   | μs   |
| t <sub>D_CStoVSENSEH</sub>                                   | MultiSense transition delay from stable current sense on Ch <sub>X</sub> to V <sub>SENSEH</sub> on Ch <sub>Y</sub> | V <sub>IN0</sub> = 5 V; V <sub>IN1</sub> = 0 V;<br>V <sub>SEN</sub> = 5 V; V <sub>SEL1</sub> = 0 V;<br>V <sub>SEL0</sub> = 0 V to 5 V;<br>I <sub>OUT0</sub> = 3 A; V <sub>OUT1</sub> = 4 V;<br>R <sub>SENSE</sub> = 1 kΩ |      |      | 20   | μs   |

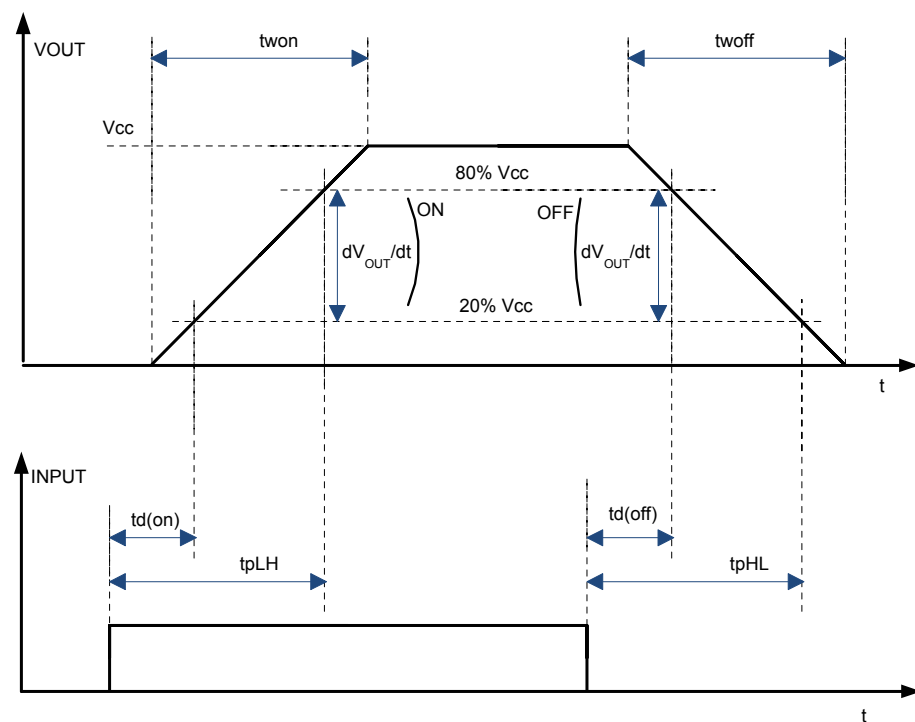
1. Parameter guaranteed by design and characterization; not subject to production test.
2. All values refer to V<sub>CC</sub> = 13 V; T<sub>j</sub> = 25°C, unless otherwise specified.
3. Total current drift over -40 °C to 150 °C, V<sub>CC</sub>: 7 V to 18 V and output current variation, respect to a calibration point measured at T<sub>j</sub> = 25 °C and V<sub>CC</sub> = 13 V.
4. V<sub>CC</sub> sensing and TC sensing are referred to GND potential.
5. Transition delay are measured up to +/- 10% of final conditions.

**Figure 4. I<sub>OUT</sub>/I<sub>SENSE</sub> versus I<sub>OUT</sub>**


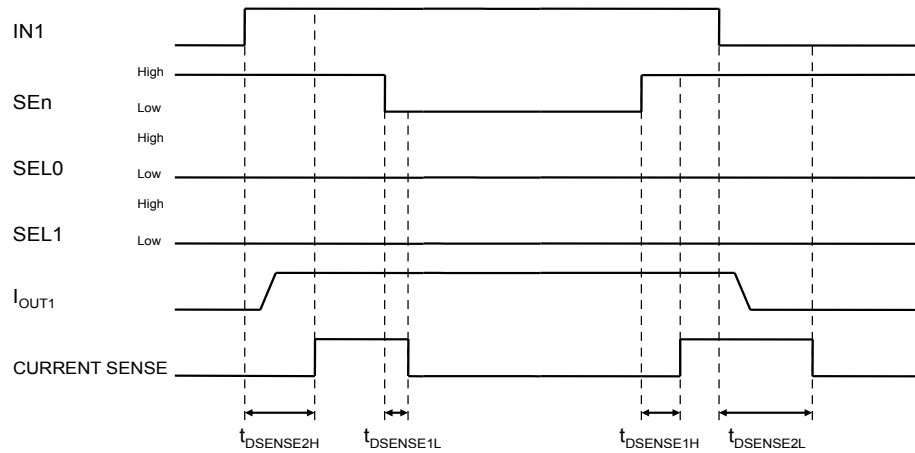
**Figure 5. Current sense accuracy versus I<sub>OUT</sub>**



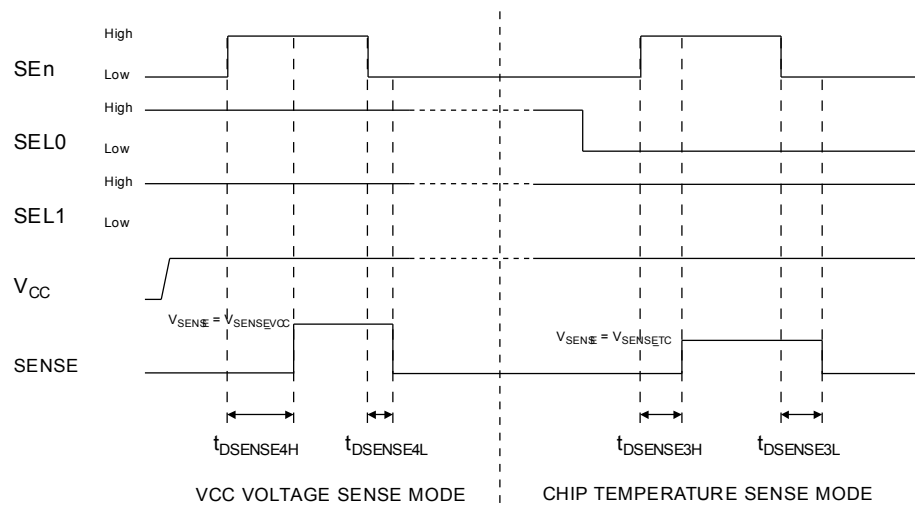
**Figure 6. Switching time and Pulse skew**



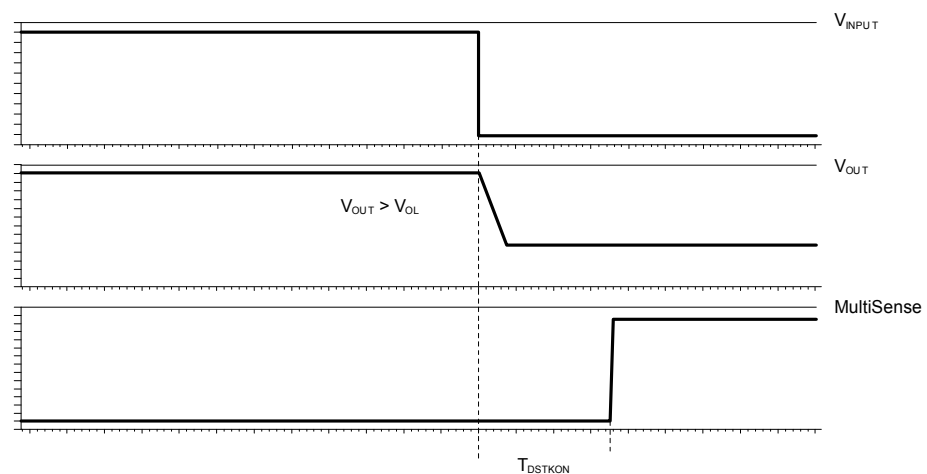
**Figure 7. MultiSense timings (current sense mode)**



**Figure 8. Multisense timings (chip temperature and VCC sense mode)**



**Figure 9. TDSTKON**



**Table 11. Truth table**

| Mode                    | Conditions                                                                          | IN<br>X | F<br>R | SE n    | SEL<br>X | OUT<br>X       | MultiSense   | Comments                                                |
|-------------------------|-------------------------------------------------------------------------------------|---------|--------|---------|----------|----------------|--------------|---------------------------------------------------------|
| Standby                 | All logic inputs low                                                                | L       | L      | L       | L        | L              | Hi-Z         | Low quiescent current consumption                       |
| Normal                  | Nominal load connected; $T_j < 150\text{ }^{\circ}\text{C}$                         | L       | X      | See (1) |          | L              | See (1)      |                                                         |
|                         |                                                                                     | H       | L      |         |          | H              | See (1)      | Outputs configured for auto-restart                     |
|                         |                                                                                     | H       | H      |         |          | H              | See (1)      | Outputs configured for Latch-off                        |
| Overload                | Overload or short to GND causing: $T_j > T_{TSD}$ or $\Delta T_j > \Delta T_{LS D}$ | L       | X      | See (1) |          | L              | See (1)      |                                                         |
|                         |                                                                                     | H       | L      |         |          | H              | See (1)      | Output cycles with temperature hysteresis               |
|                         |                                                                                     | H       | H      |         |          | L              | See (1)      | Output latches-off                                      |
| Undervoltage            | $V_{CC} < V_{USD}$ (falling)                                                        | X       | X      | X       | X        | L<br>L         | Hi-Z<br>Hi-Z | Re-start when $V_{CC} > V_{USD} + V_{USDhyst}$ (rising) |
| OFF-state diagnostics   | Short to $V_{CC}$                                                                   | L       | X      | See (1) |          | H              | See (1)      |                                                         |
|                         | Open-load                                                                           | L       | X      |         |          | H              | See (1)      | External pull-up                                        |
| Negative output voltage | Inductive loads turnoff                                                             | L       | X      | See (1) |          | $< 0\text{ V}$ | See (1)      |                                                         |

1. Refer to Table 12

**Table 12. MultiSense multiplexer addressing**

| SEn | SEL <sub>1</sub> | SEL <sub>0</sub> | MUXchannel           | MultiSense output            |                              |                          |                 |
|-----|------------------|------------------|----------------------|------------------------------|------------------------------|--------------------------|-----------------|
|     |                  |                  |                      | Normal mode                  | Overload                     | OFF-state diag.<br>(1)   | Negative output |
| L   | X                | X                |                      |                              | Hi-Z                         |                          |                 |
| H   | L                | L                | Channel 0 diagnostic | $I_{SENSE} = 1/K * I_{OUT0}$ | $V_{SENSE} = V_{SENSEH}$     | $V_{SENSE} = V_{SENSEH}$ | Hi-Z            |
| H   | L                | H                | Channel 1 diagnostic | $I_{SENSE} = 1/K * I_{OUT1}$ | $V_{SENSE} = V_{SENSEH}$     | $V_{SENSE} = V_{SENSEH}$ | Hi-Z            |
| H   | H                | L                | $T_{CHIP}$ Sense     |                              | $V_{SENSE} = V_{SENSE\_TC}$  |                          |                 |
| H   | H                | H                | $V_{CC}$ Sense       |                              | $V_{SENSE} = V_{SENSE\_VCC}$ |                          |                 |

1. In case the output channel corresponding to the selected MUX channel is latched off while the relevant input is low, Multisense pin delivers feedback according to OFF-State diagnostic.

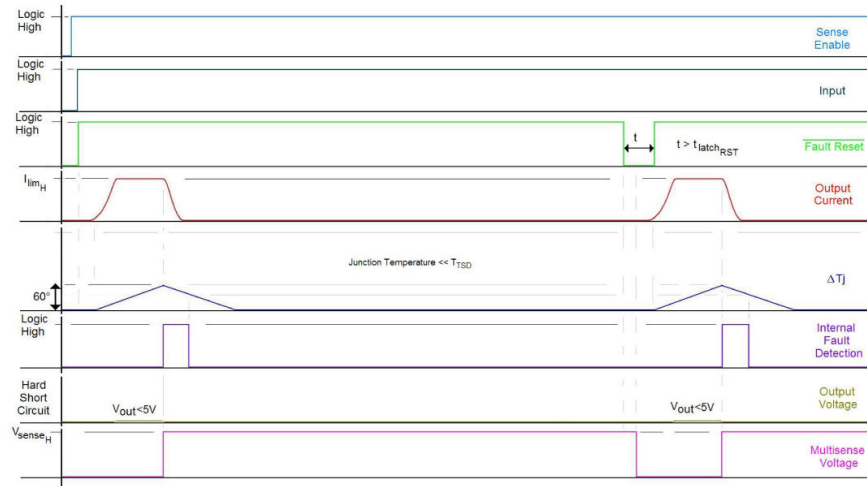
 Example 1:  $FR = 1$ ;  $IN_0 = 0$ ;  $OUT_0 = L$  (latched); MUX channel = channel 0 diagnostic; Mutisense = 0.

 Example 2:  $FR = 1$ ;  $IN_0 = 0$ ;  $OUT_0 =$  latched,  $V_{OUT0} > V_{OL}$ ; MUX channel = channel 0 diagnostic; Mutisense =  $V_{SENSEH}$

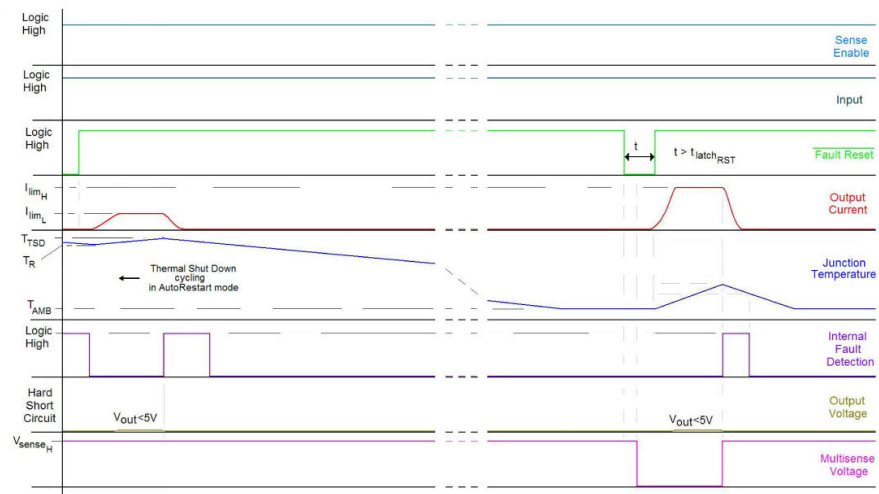


## 2.4 Waveforms

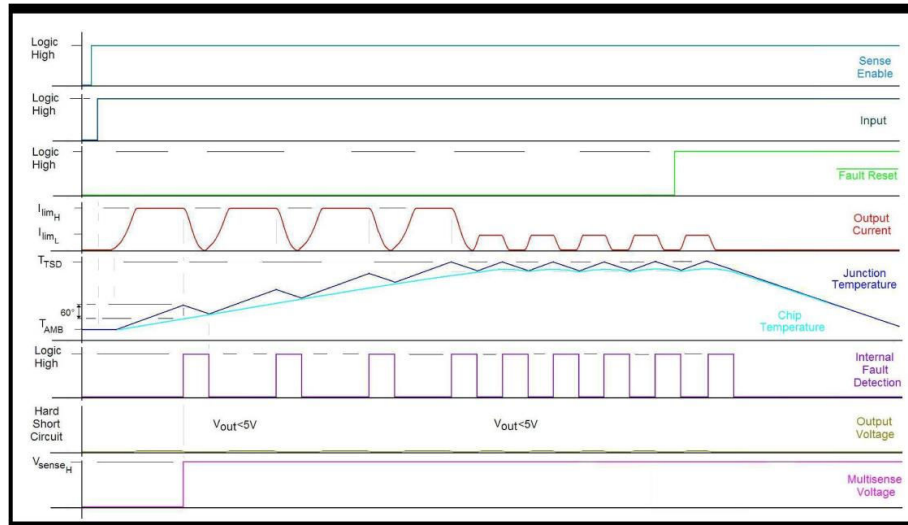
**Figure 10. Latch functionality - behavior in hard short circuit condition ( $T_{AMB} \ll T_{TSD}$ )**



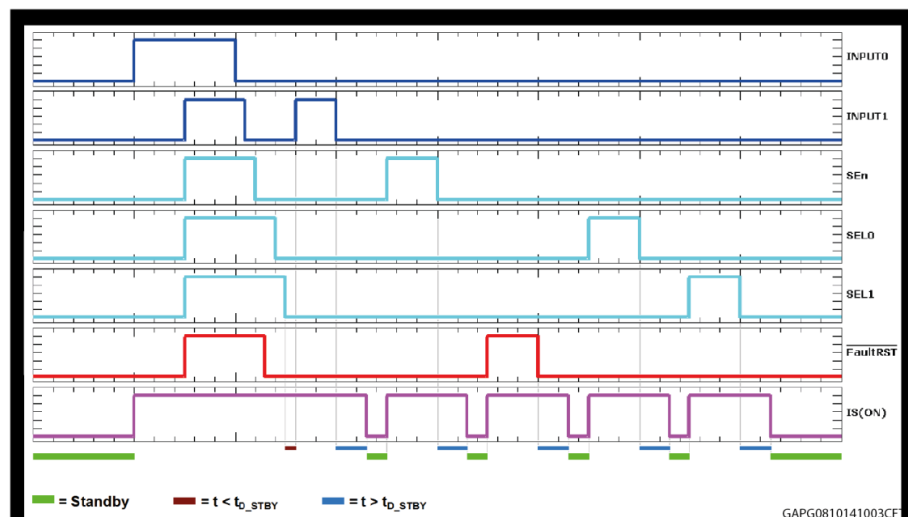
**Figure 11. Latch functionality - behavior in hard short circuit condition**



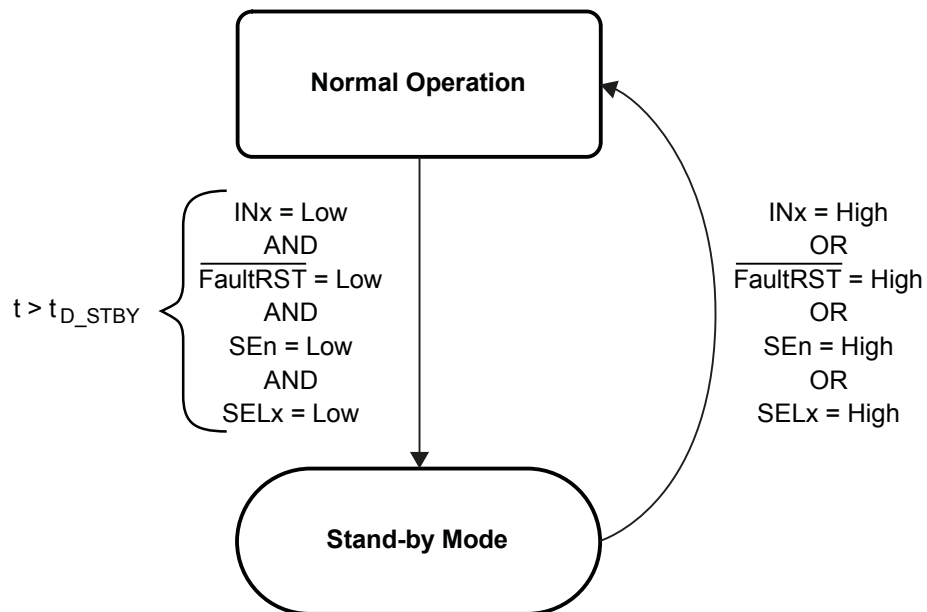
**Figure 12. Latch functionality - behavior in hard short circuit condition (autorestart mode + latch off)**



**Figure 13. Standby mode activation**

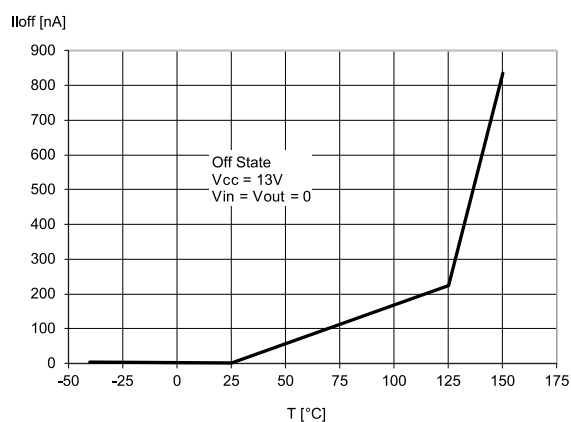


**Figure 14. Standby state diagram**

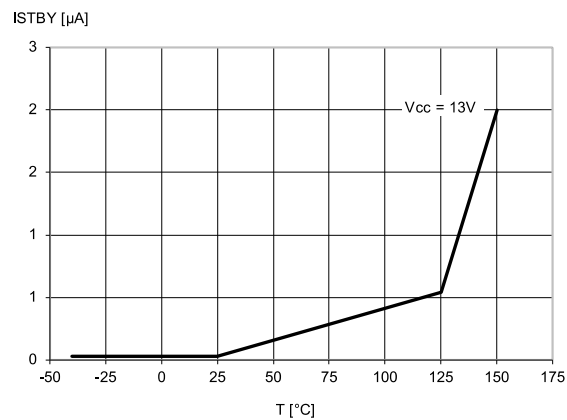


## 2.5 Electrical characteristics curves

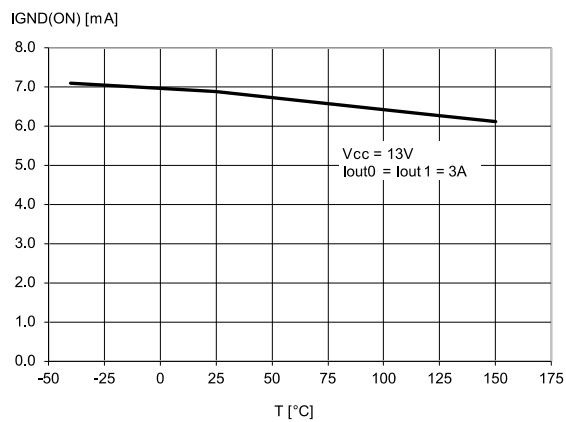
**Figure 15. OFF-state output current**



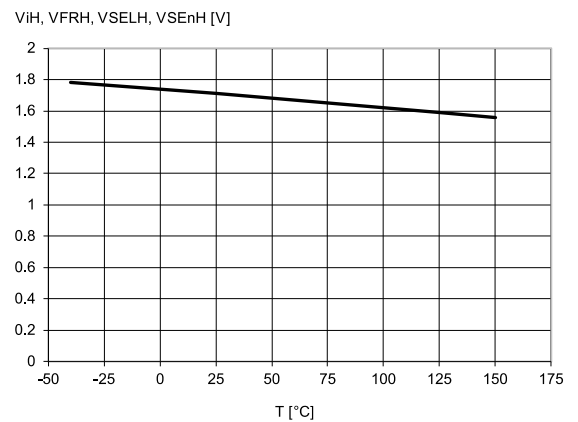
**Figure 16. Standby current**



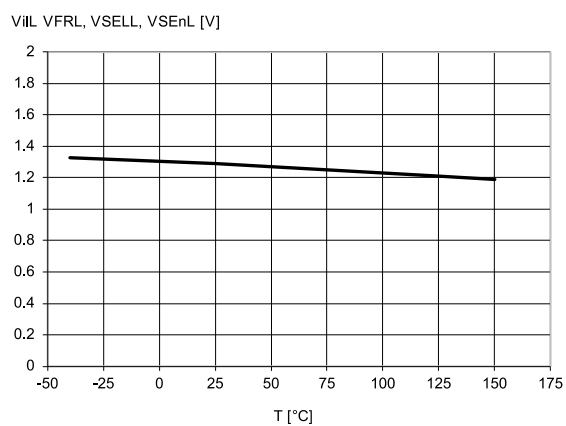
**Figure 17. IGND(ON) vs. Iout**



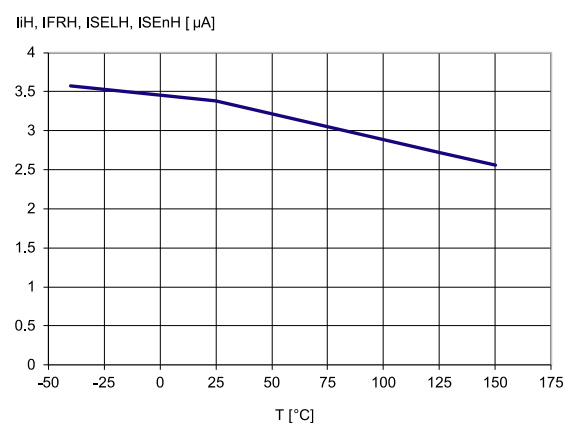
**Figure 18. Logic Input high level voltage**



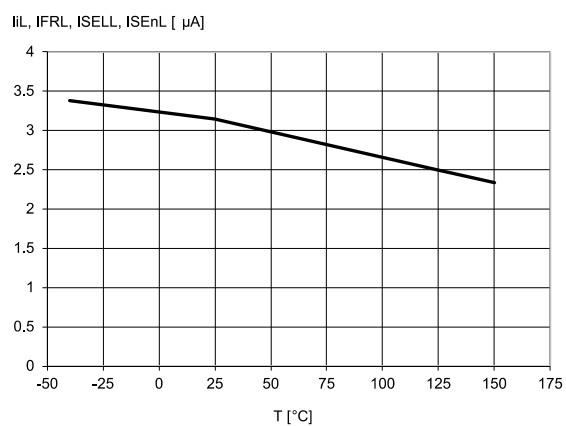
**Figure 19. Logic Input low level voltage**



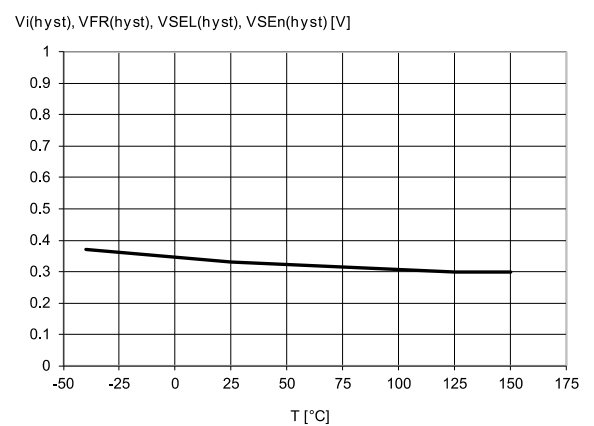
**Figure 20. High level logic input current**



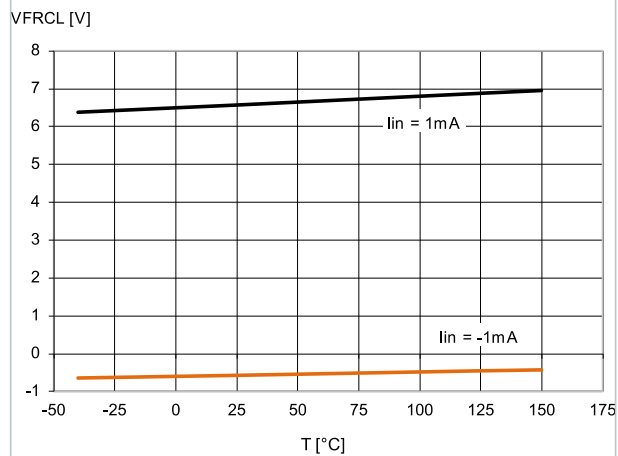
**Figure 21. Low level logic input current**



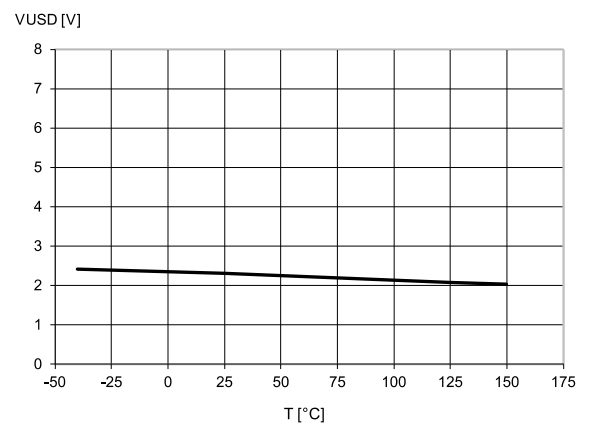
**Figure 22. Logic Input hysteresis voltage**



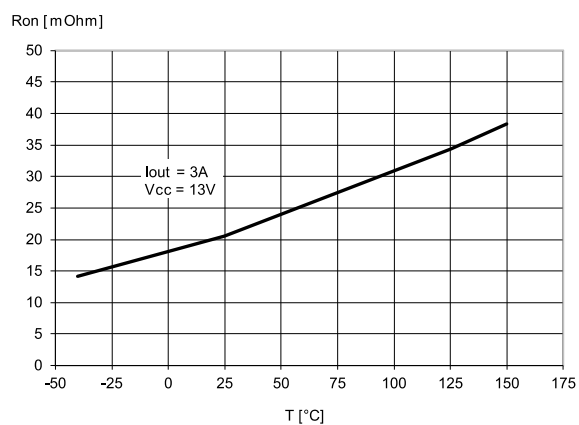
**Figure 23. FaultRST Input clamp voltage**



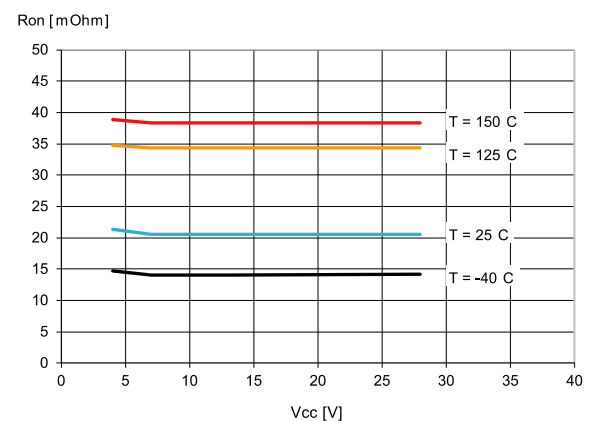
**Figure 24. Undervoltage shutdown**



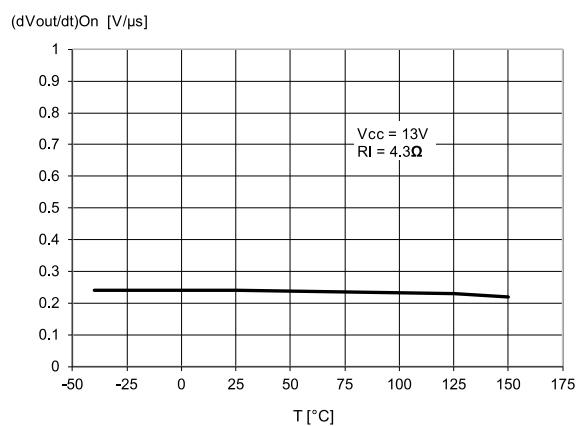
**Figure 25. On-state resistance vs. Tcase**



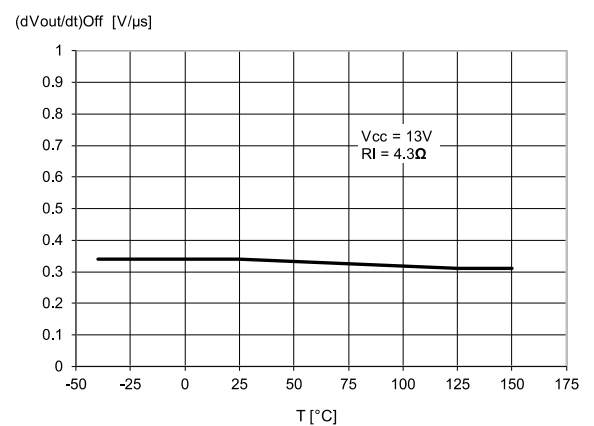
**Figure 26. On-state resistance vs. VCC**



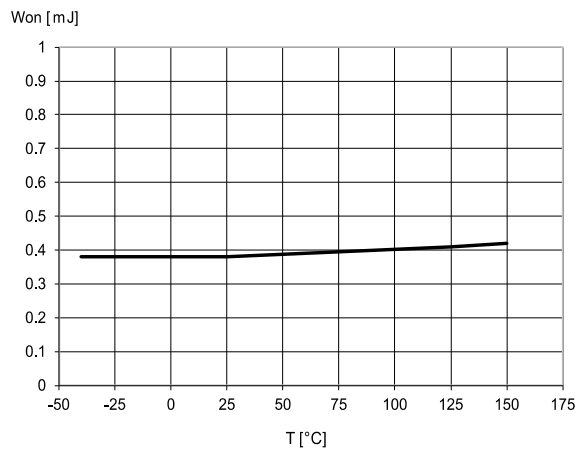
**Figure 27. Turn-on voltage slope**



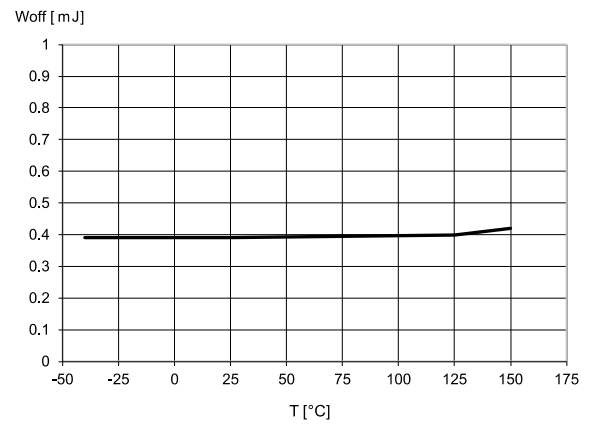
**Figure 28. Turn-off voltage slope**



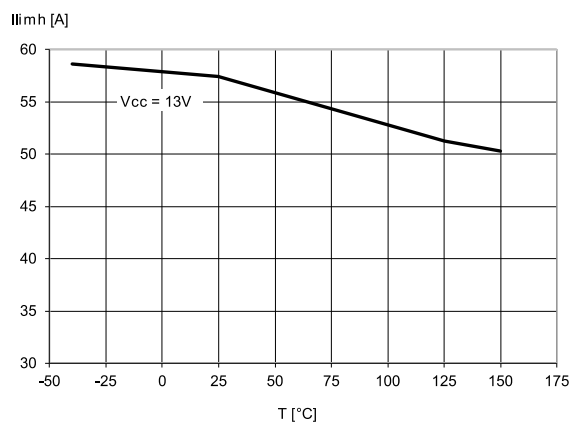
**Figure 29. Won vs. Tcase**



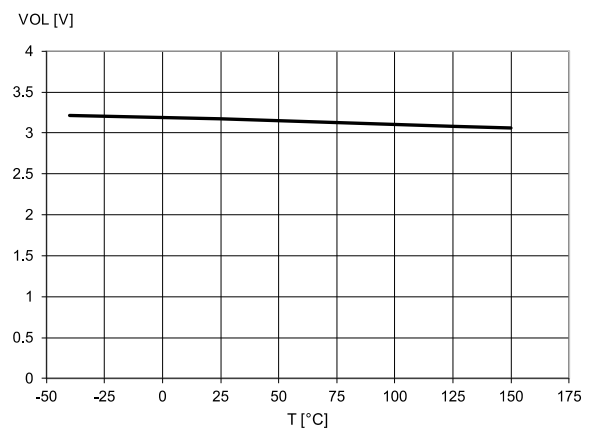
**Figure 30. Woff vs. Tcase**



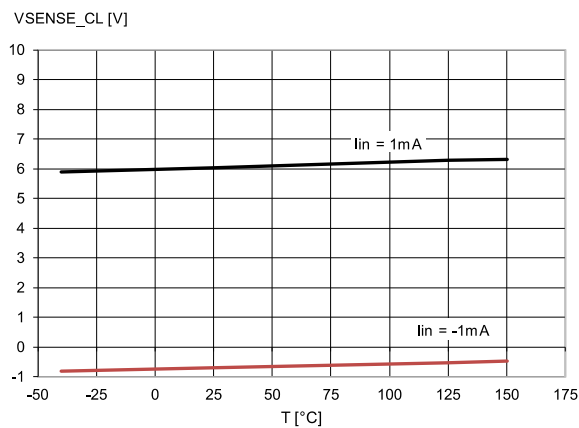
**Figure 31. Ilimh vs. Tcase**



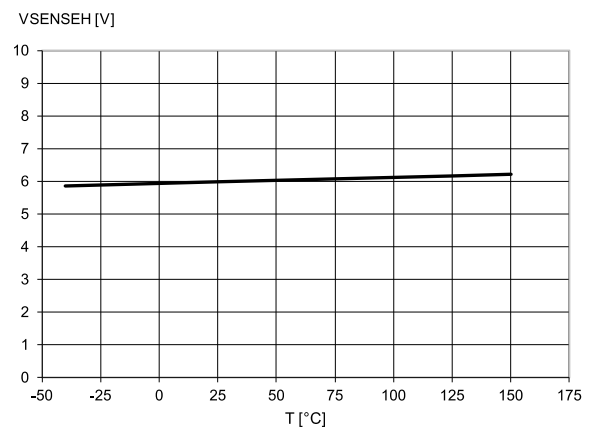
**Figure 32. OFF-state open-load voltage detection threshold**



**Figure 33. Vsense clamp vs. Tcase**



**Figure 34. Vsenseh vs. Tcase**



## 3 Protections

### 3.1 Power limitation

The basic working principle of this protection consists of an indirect measurement of the junction temperature swing  $\Delta T_j$  through the direct measurement of the spatial temperature gradient on the device surface in order to automatically shut off the output MOSFET as soon as  $\Delta T_j$  exceeds the safety level of  $\Delta T_{j\_SD}$ . According to the voltage level on the FaultRST pin, the output MOSFET switches on and cycles with a thermal hysteresis according to the maximum instantaneous power which can be handled (FaultRST = Low) or remains off (FaultRST = High). The protection prevents fast thermal transient effects and, consequently, reduces thermo-mechanical fatigue.

### 3.2 Thermal shutdown

In case the junction temperature of the device exceeds the maximum allowed threshold (typically 175°C), it automatically switches off and the diagnostic indication is triggered. According to the voltage level on the FaultRST pin, the device switches on again as soon as its junction temperature drops to  $T_R$  (FaultRST = Low) or remains off (FaultRST = High).

### 3.3 Current limitation

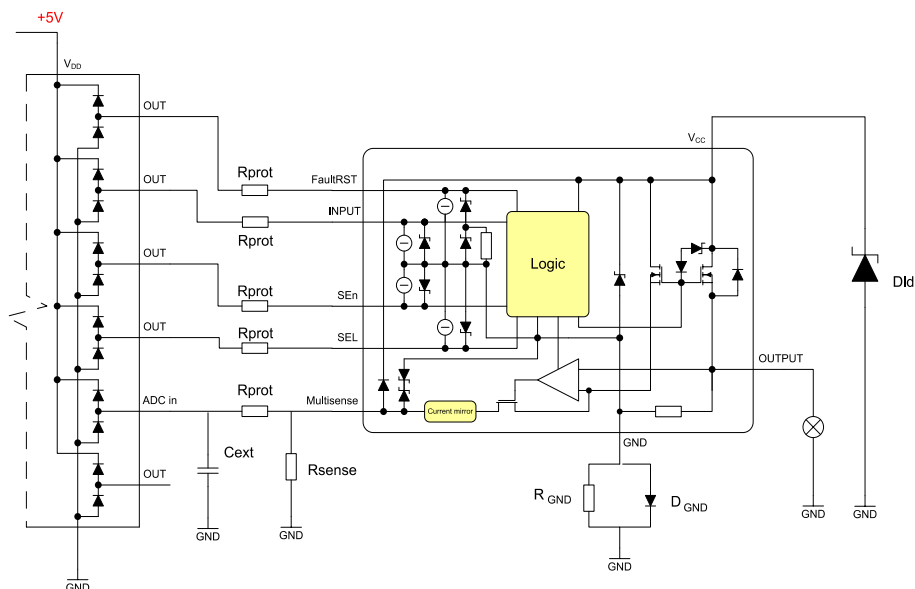
The device is equipped with an output current limiter in order to protect the silicon as well as the other components of the system (e.g. bonding wires, wiring harness, connectors, loads, etc.) from excessive current flow. Consequently, in case of short circuit, overload or during load power-up, the output current is clamped to a safety level,  $I_{LIMH}$ , by operating the output power MOSFET in the active region.

### 3.4 Negative voltage clamp

In case the device drives inductive load, the output voltage reaches a negative value during turn off. A negative voltage clamp structure limits the maximum negative voltage to a certain value,  $V_{DEMAG}$ , allowing the inductor energy to be dissipated without damaging the device.

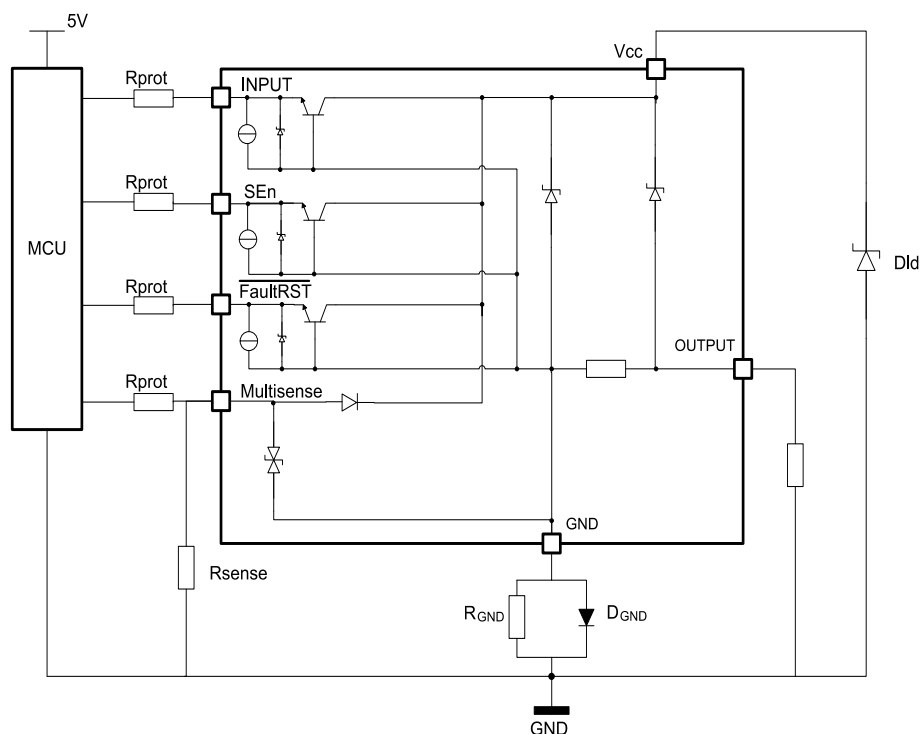
## 4 Application information

**Figure 35. Application diagram**



### 4.1 GND protection network against reverse battery

**Figure 36. Simplified internal structure**



#### 4.1.1 Diode (DGND) in the ground line

A resistor (typ.  $R_{GND} = 4.7 \text{ k}\Omega$ ) should be inserted in parallel to  $D_{GND}$  if the device drives an inductive load.



This small signal diode can be safely shared amongst several different HSDs. Also in this case, the presence of the ground network produces a shift ( $\approx 600$  mV) in the input threshold and in the status output values if the microprocessor ground is not common to the device ground. This shift does not vary if more than one HSD shares the same diode/resistor network.

## 4.2 Immunity against transient electrical disturbances

The immunity of the device against transient electrical emissions, conducted along the supply lines and injected into the  $V_{CC}$  pin, is tested in accordance with ISO7637-2:2011 (E) and ISO 16750-2:2010.

The related function performance status classification is shown in Table 13.

Test pulses are applied directly to DUT (Device Under Test) both in ON and OFF-state and in accordance to ISO 7637-2:2011(E), chapter 4. The DUT is intended as the present device only, without components and accessed through  $V_{CC}$  and GND terminals.

Status II is defined in ISO 7637-1 Function Performance Status Classification (FPSC) as follows: "The function does not perform as designed during the test but returns automatically to normal operation after the test".

**Table 13. ISO 7637-2 - electrical transient conduction along supply line**

| Test Pulse<br>2011(E)                          | Test pulse severity level with<br>Status II<br>functional performance<br>status |                   | Minimum number of<br>pulses or test time | Burst cycle / pulse<br>repetition time |        | Pulse duration and pulse<br>generator internal<br>impedance |
|------------------------------------------------|---------------------------------------------------------------------------------|-------------------|------------------------------------------|----------------------------------------|--------|-------------------------------------------------------------|
|                                                | Level                                                                           | US <sup>(1)</sup> |                                          | min                                    | max    |                                                             |
| 1                                              | III                                                                             | -112 V            | 500 pulses                               | 0.5 s                                  |        | 2 ms, 10 $\Omega$                                           |
| 2a <sup>(2)</sup>                              | III                                                                             | +55 V             | 500 pulses                               | 0.2 s                                  | 5 s    | 50 $\mu$ s, 2 $\Omega$                                      |
| 3a                                             | IV                                                                              | -220 V            | 1h                                       | 90 ms                                  | 100 ms | 0.1 $\mu$ s, 50 $\Omega$                                    |
| 3b                                             | IV                                                                              | +150 V            | 1h                                       | 90 ms                                  | 100 ms | 0.1 $\mu$ s, 50 $\Omega$                                    |
| 4 <sup>(3)</sup>                               | IV                                                                              | -7 V              | 1 pulse                                  |                                        |        | 100 ms, 0.01 $\Omega$                                       |
| <b>Load dump according to ISO 16750-2:2010</b> |                                                                                 |                   |                                          |                                        |        |                                                             |
| Test B <sup>(2)</sup>                          |                                                                                 | 40 V              | 5 pulse                                  | 1 min                                  |        | 400 ms, 2 $\Omega$                                          |

1. US is the peak amplitude as defined for each test pulse in ISO 7637-2:2011(E), chapter 5.6.

2. With 40 V external suppressor referred to ground ( $-40^{\circ}\text{C} < T_j < 150^{\circ}\text{C}$ ).

3. Test pulse from ISO 7637-2:2004(E).

## 4.3 MCU I/Os protection

If a ground protection network is used and negative transients are present on the  $V_{CC}$  line, the control pins will be pulled negative. ST suggests to insert a resistor ( $R_{prot}$ ) in line both to prevent the microcontroller I/O pins from latching-up and to protect the HSD inputs.

The value of these resistors is a compromise between the leakage current of microcontroller and the current required by the HSD I/Os (Input levels compatibility) with the latch-up limit of microcontroller I/Os.

### Equation

$$V_{CCpeak}/I_{latchup} \leq R_{prot} \leq (V_{OH\mu C} - V_{IH} - V_{GND}) / I_{IHmax} \quad (1)$$

Calculation example:

For  $V_{CCpeak} = -150$  V;  $I_{latchup} \geq 20$  mA;  $V_{OH\mu C} \geq 4.5$  V

$7.5 \text{ k}\Omega \leq R_{prot} \leq 140 \text{ k}\Omega$ .

Recommended values:  $R_{prot} = 15 \text{ k}\Omega$

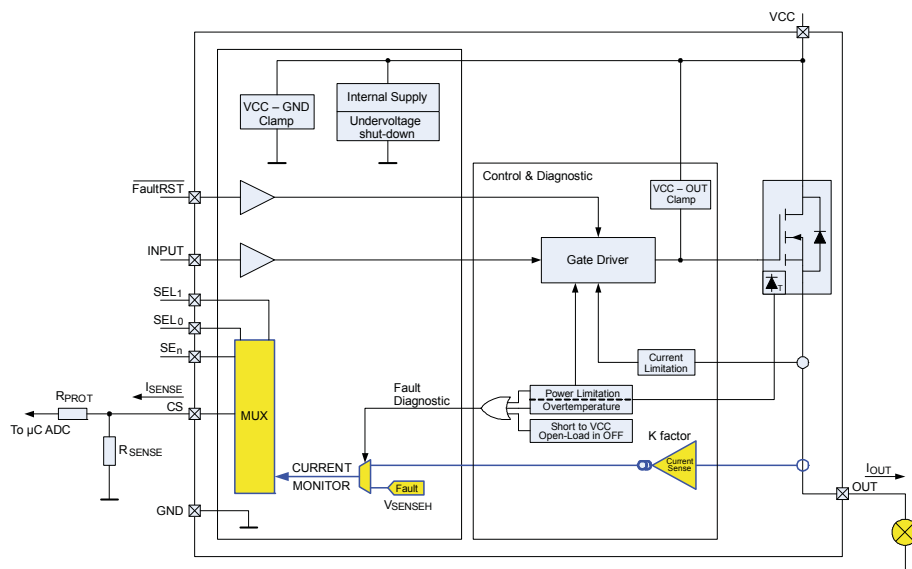
## 4.4 Multisense - analog current sense

Diagnostic information on device and load status are provided by an analog output pin (MultiSense) delivering the following signals:

- Current monitor: current mirror of channel output current
- $V_{CC}$  monitor: voltage proportional to  $V_{CC}$
- $T_{CASE}$ : voltage proportional to chip temperature

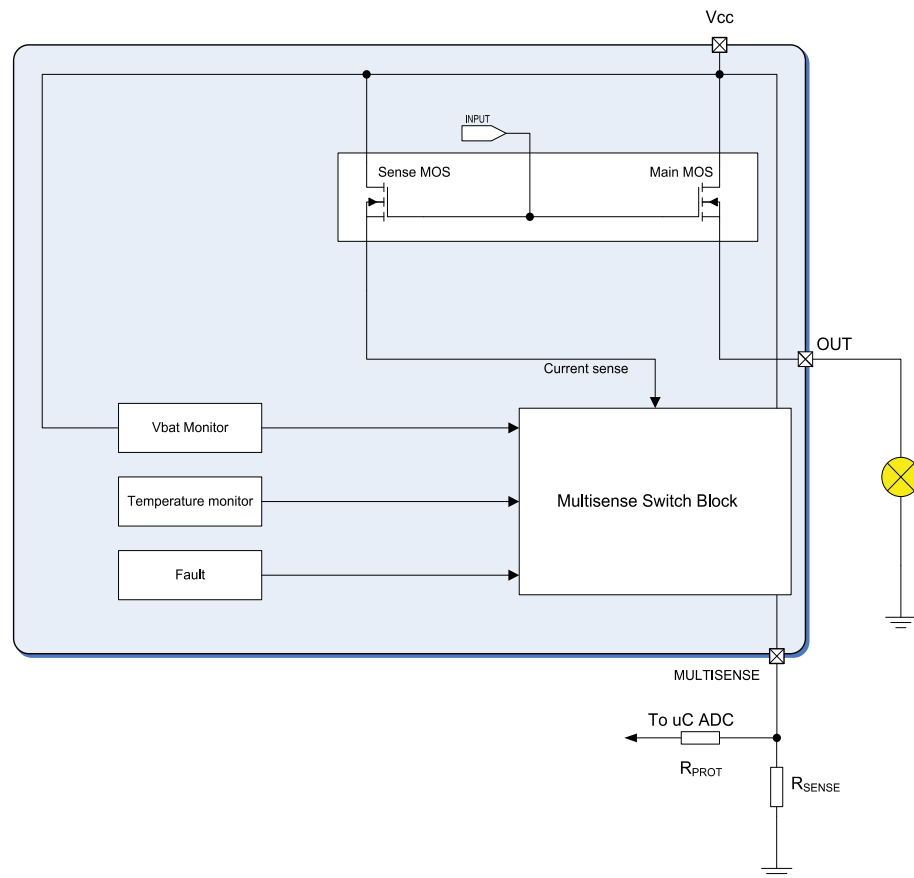
Those signals are routed through an analog multiplexer which is configured and controlled by means of SELx and SEn pins, according to the address map in [Table 12. MultiSense multiplexer addressing](#).

**Figure 37. MultiSense and diagnostic – block diagram**



#### 4.4.1 Principle of Multisense signal generation

**Figure 38. MultiSense block diagram**



##### Current monitor

When current mode is selected in the MultiSense, this output is capable to provide:

- Current mirror proportional to the load current in normal operation, delivering current proportional to the load according to known ratio named **K**
- Diagnostics flag in fault conditions delivering fixed voltage  $V_{SENSEH}$

The current delivered by the current sense circuit,  $I_{SENSE}$ , can be easily converted to a voltage  $V_{SENSE}$  by using an external sense resistor,  $R_{SENSE}$ , allowing continuous load monitoring and abnormal condition detection.

##### Normal operation (channel ON, no fault, SEn active)

While device is operating in normal conditions (no fault intervention),  $V_{SENSE}$  calculation can be done using simple equations

Current provided by MultiSense output:  $I_{SENSE} = I_{OUT}/K$

Voltage on  $R_{SENSE}$ :  $V_{SENSE} = R_{SENSE} \cdot I_{SENSE} = R_{SENSE} \cdot I_{OUT}/K$

Where:

- $V_{SENSE}$  is voltage measurable on  $R_{SENSE}$  resistor
- $I_{SENSE}$  is current provided from MultiSense pin in current output mode
- $I_{OUT}$  is current flowing through output
- K factor represents the ratio between PowerMOS cells and SenseMOS cells; its spread includes geometric factor spread, current sense amplifier offset and process parameters spread of overall circuitry specifying ratio between  $I_{OUT}$  and  $I_{SENSE}$ .

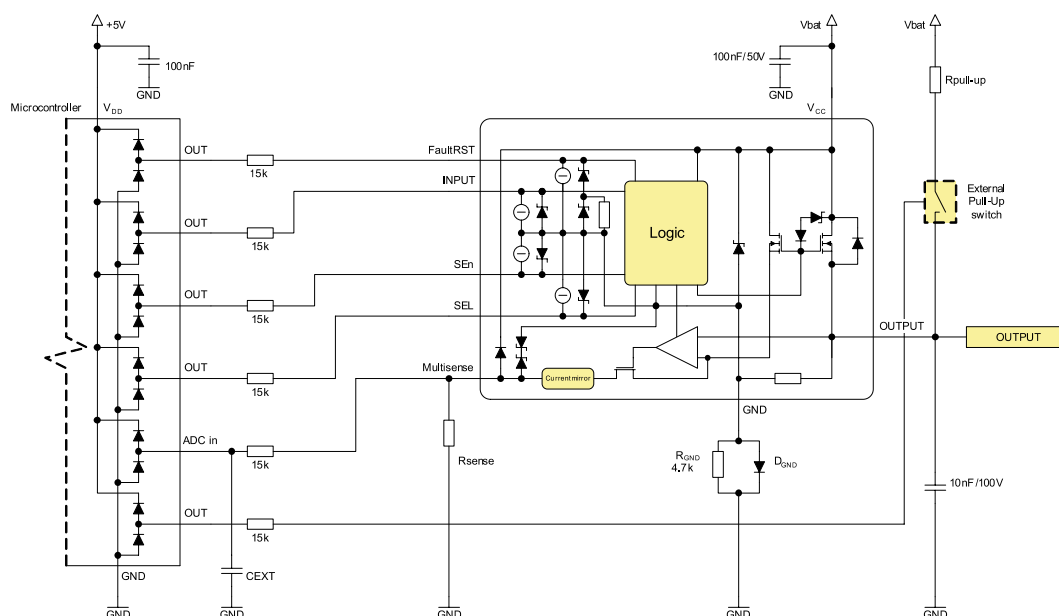
##### Failure flag indication

In case of power limitation/overtemperature, the fault is indicated by the MultiSense pin which is switched to a “current limited” voltage source,  $V_{SENSEH}$ .

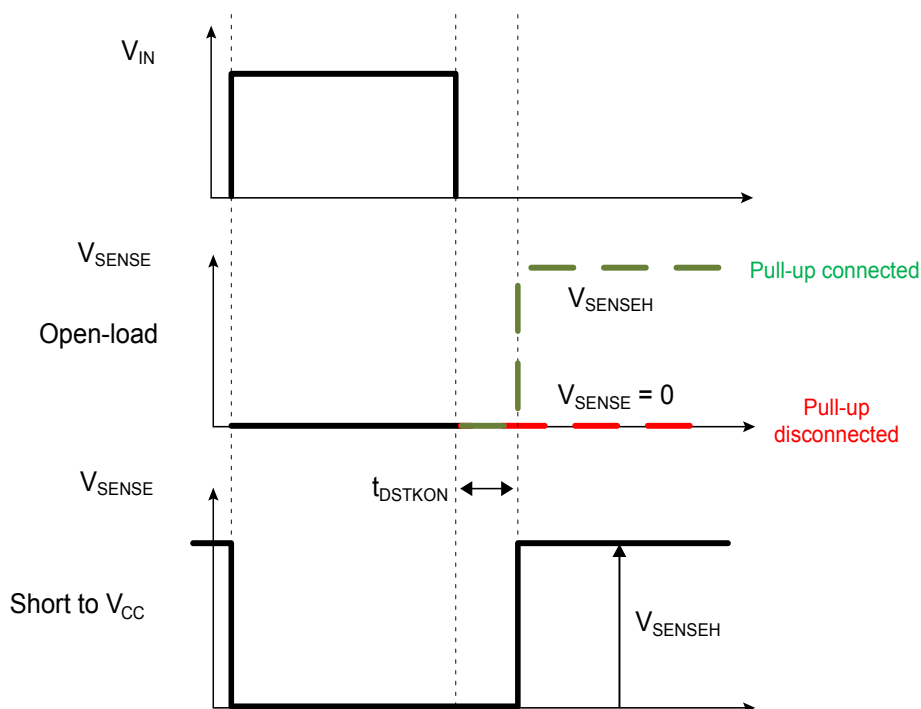
In any case, the current sourced by the MultiSense in this condition is limited to  $I_{SENSEH}$ .

The typical behavior in case of overload or hard short circuit is shown in [Section 2.4: Waveforms](#).

**Figure 39. Analogue HSD – open-load detection in off-state**



**Figure 40. Open-load / short to VCC condition**



**Table 14. MultiSense pin levels in off-state**

| Condition | Output             | MultiSense | SEn |
|-----------|--------------------|------------|-----|
| Open-load | $V_{OUT} > V_{OL}$ | Hi-Z       | L   |

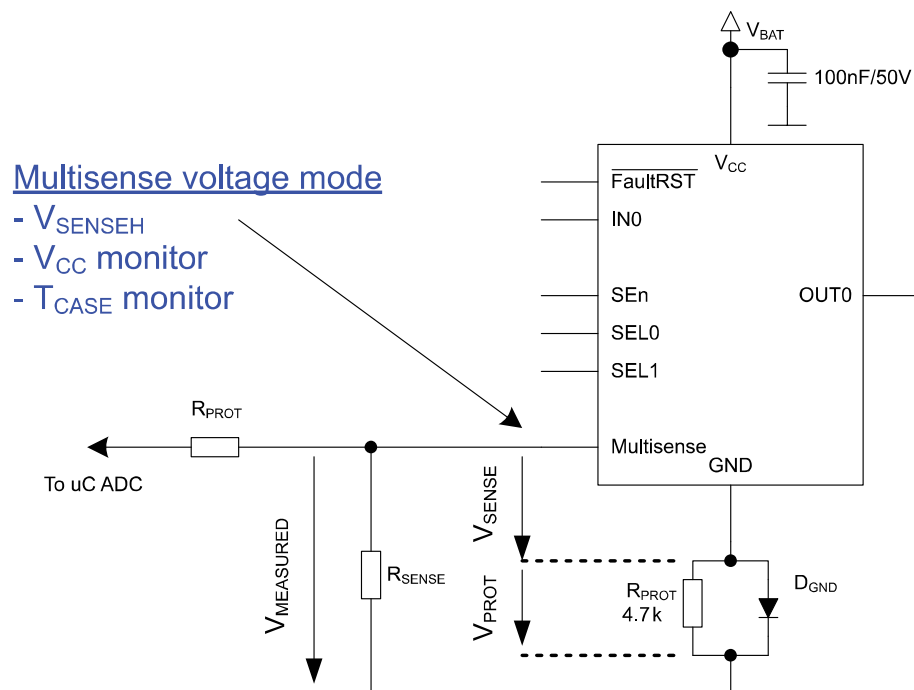
| Condition         | Output             | MultiSense   | SEn |
|-------------------|--------------------|--------------|-----|
| Open-load         | $V_{OUT} > V_{OL}$ | $V_{SENSEH}$ | H   |
|                   | $V_{OUT} < V_{OL}$ | Hi-Z         | L   |
|                   |                    | 0            | H   |
| Short to $V_{CC}$ | $V_{OUT} > V_{OL}$ | Hi-Z         | L   |
|                   |                    | $V_{SENSEH}$ | H   |
| Nominal           | $V_{OUT} < V_{OL}$ | Hi-Z         | L   |
|                   |                    | 0            | H   |

#### 4.4.2 TCASE and VCC monitor

In this case, MultiSense output operates in voltage mode and output level is referred to device GND. Care must be taken in case a GND network protection is used, because a voltage shift is generated between the device GND and the microcontroller input GND reference.

Figure 41 shows the link between  $V_{MEASURED}$  and the real  $V_{SENSE}$  signal.

**Figure 41. GND voltage shift**



#### V<sub>CC</sub> monitor

Battery monitoring channel provides  $V_{SENSE} = V_{CC} / 8$ .

#### Case temperature monitor

Case temperature monitor is capable of providing information about the actual device temperature. Since a diode is used for temperature sensing, the following equation describes the link between temperature and output  $V_{SENSE}$  level:

$V_{SENSE\_TC}(T) = V_{SENSE\_TC}(T_0) + dV_{SENSE\_TC} / dT * (T - T_0)$  where  $dV_{SENSE\_TC} / dT \sim$  typically  $-5.5$  mV/K (for temperature range  $(-40^{\circ}\text{C}$  to  $150^{\circ}\text{C})$ ).

#### 4.4.3 Short to V<sub>CC</sub> and OFF-state open-load detection

Short to  $V_{CC}$

A short circuit between  $V_{CC}$  and output is indicated by the relevant current sense pin set to  $V_{SENSEH}$  during the device off-state. Small or no current is delivered by the current sense during the on-state depending on the nature of the short circuit.

#### **OFF-state open-load with external circuitry**

Detection of an open-load in off mode requires an external pull-up resistor  $R_{PU}$  connecting the output to a positive supply voltage  $V_{PU}$ .

It is preferable that  $V_{PU}$  is switched off during the module standby mode in order to avoid the overall standby current consumption to increase in normal conditions, i.e. when load is connected.

$R_{PU}$  must be selected in order to ensure  $V_{OUT} > V_{OLmax}$  in accordance with the following equation:

#### **Equation**

$$R_{PU} < \frac{V_{PU} - 4}{I_{L(off2)min@4V}} \quad (2)$$

## 5

## Maximum demagnetization energy (VCC = 16 V)

Figure 42. Maximum turn off current versus inductance

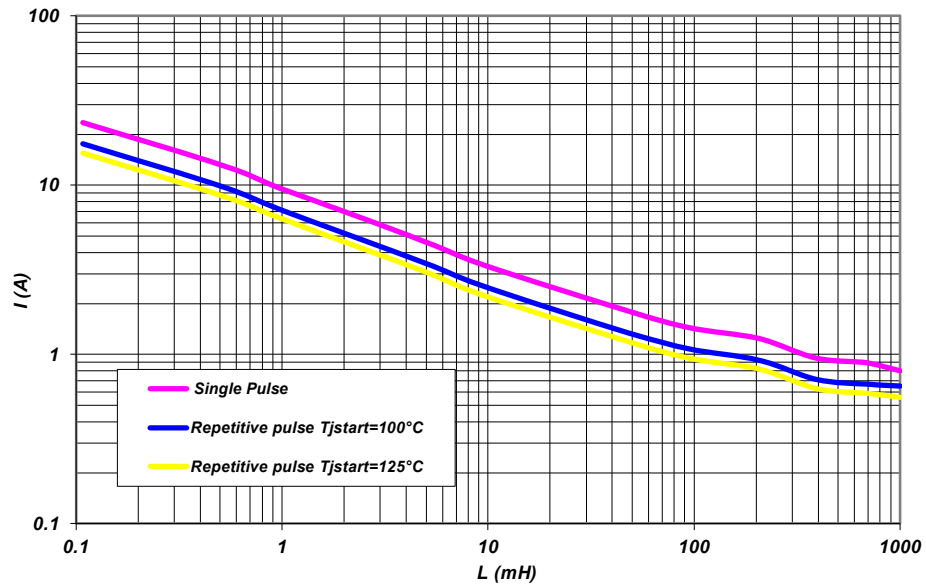
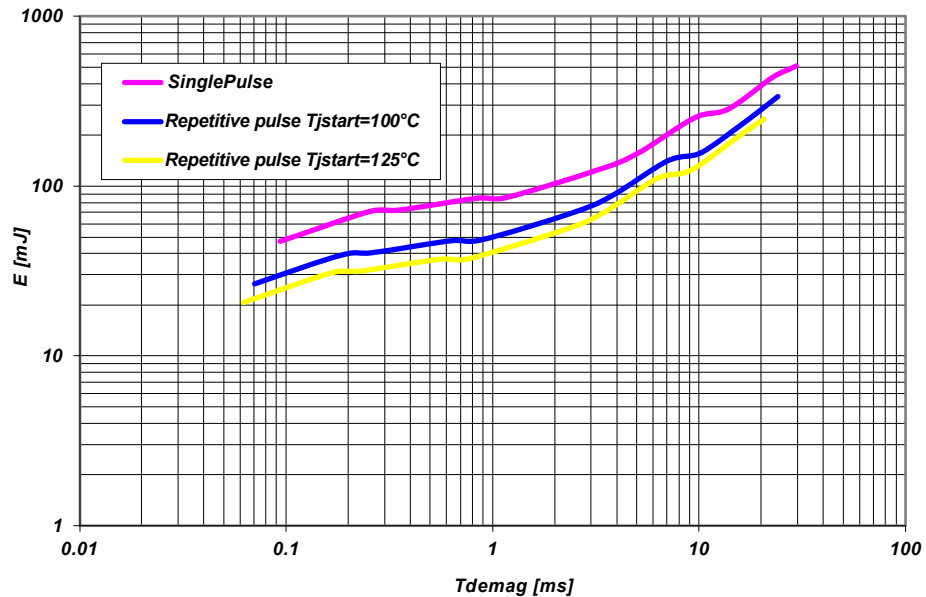


Figure 43. Maximum Maximum turn off Energy versus Tdemag

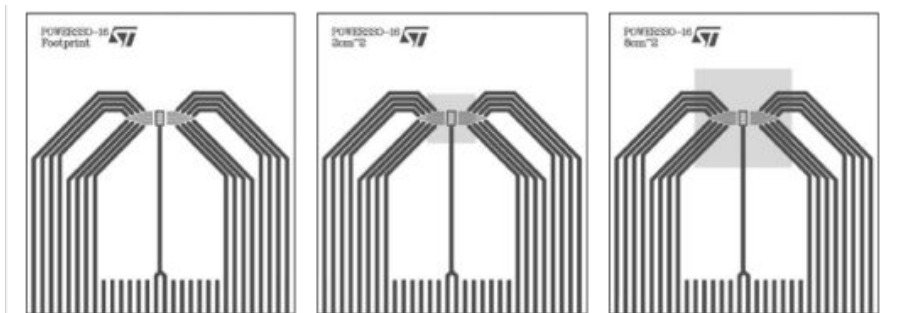


Note: Values are generated with  $R_L = 0 \Omega$ . In case of repetitive pulses,  $T_{jstart}$  (at the beginning of each demagnetization) of every pulse must not exceed the temperature specified above for curves A and B.

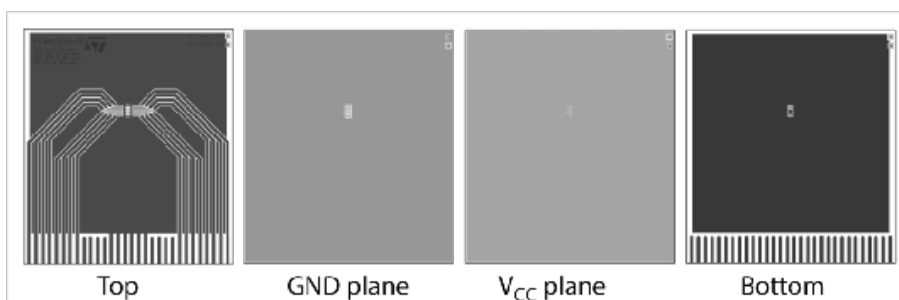
## 6 Package and PCB thermal data

### 6.1 PowerSSO-16 thermal data

**Figure 44. PowerSSO-16 on two-layers PCB (2s0p to JEDEC JESD 51-5)**



**Figure 45. PowerSSO-16 on four-layers PCB (2s2p to JEDEC JESD 51-7)**



**Table 15. PCB properties**

| Dimension                                     | Value                                             |
|-----------------------------------------------|---------------------------------------------------|
| Board finish thickness                        | 1.6 mm +/- 10%                                    |
| Board dimension                               | 77 mm x 86 mm                                     |
| Board material                                | FR4                                               |
| Copper thickness (top and bottom layers)      | 0.070 mm                                          |
| Copper thickness (inner layers)               | 0.035 mm                                          |
| Thermal vias separation                       | 1.2 mm                                            |
| Thermal via diameter                          | 0.3 mm +/- 0.08 mm                                |
| Copper thickness on vias                      | 0.025 mm                                          |
| Footprint dimension (top layer)               | 2.2 mm x 3.9 mm                                   |
| Heatsink copper area dimension (bottom layer) | Footprint, 2 cm <sup>2</sup> or 8 cm <sup>2</sup> |



Figure 46. Rthj-amb vs PCB copper area in open box free air condition (one channel on)

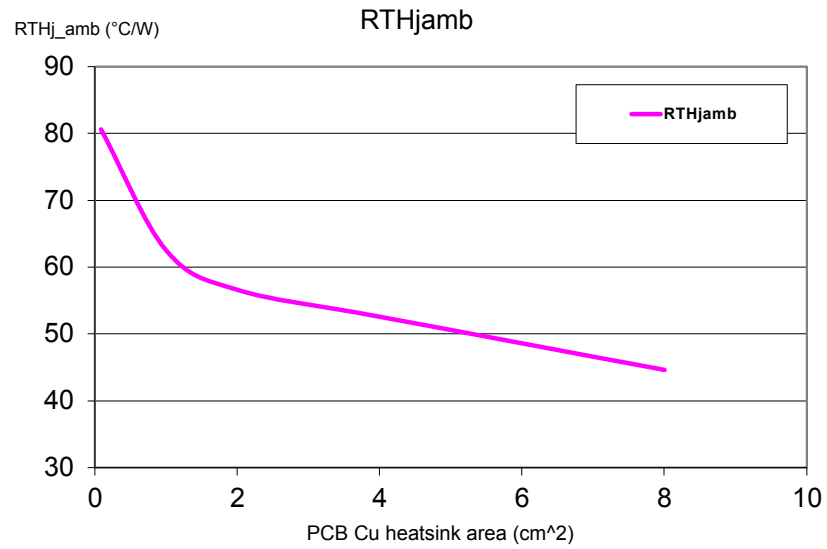
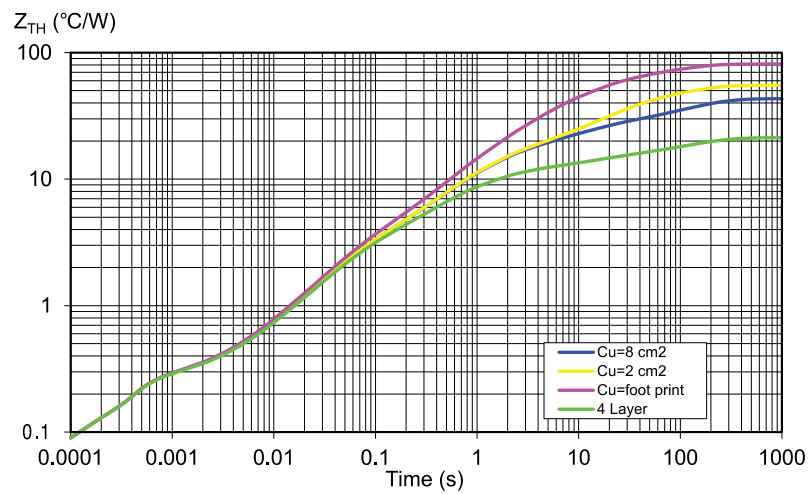


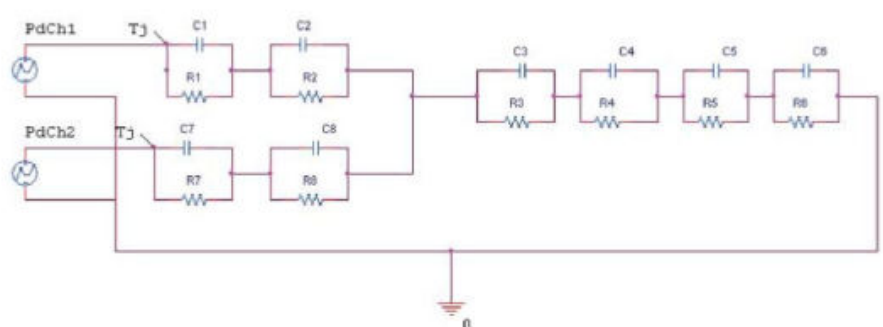
Figure 47. PowerSSO-16 thermal impedance junction ambient single pulse (one channel on)



Equation: pulse calculation formula

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta) \quad (3)$$

where  $\delta = tP/T$

**Figure 48. Thermal fitting model of a double-channel HSD in PowerSSO-16**


**Note:** The fitting model is a simplified thermal tool and is valid for transient evolutions where the embedded protections (power limitation or thermal cycling during thermal shutdown) are not triggered.

**Table 16. Thermal parameters**

| Area/island (cm <sup>2</sup> ) | Footprint | 2   | 8   | 4L  |
|--------------------------------|-----------|-----|-----|-----|
| R1 = R7 (°C/W)                 | 0.25      |     |     |     |
| R2 = R8 (°C/W)                 | 2         |     |     |     |
| R3 (°C/W)                      | 7         | 7   | 7   | 5   |
| R4 (°C/W)                      | 16        | 6   | 6   | 4   |
| R5 (°C/W)                      | 30        | 20  | 10  | 3   |
| R6 (°C/W)                      | 26        | 20  | 18  | 7   |
| C1 = C7 (W.s/°C)               | 0.001     |     |     |     |
| C2 = C8 (W.s/°C)               | 0.025     |     |     |     |
| C3 (W.s/°C)                    | 0.1       |     |     |     |
| C4 (W.s/°C)                    | 0.2       | 0.3 | 0.3 | 0.4 |
| C5 (W.s/°C)                    | 0.4       | 1   | 1   | 4   |
| C6 (W.s/°C)                    | 3         | 5   | 7   | 18  |

## 7 Package information

To meet environmental requirements, ST offers these devices in different grades of **ECOPACK** packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions, and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

### 7.1 PowerSSO-16 package information

Figure 49. PowerSSO-16 package dimensions (A)

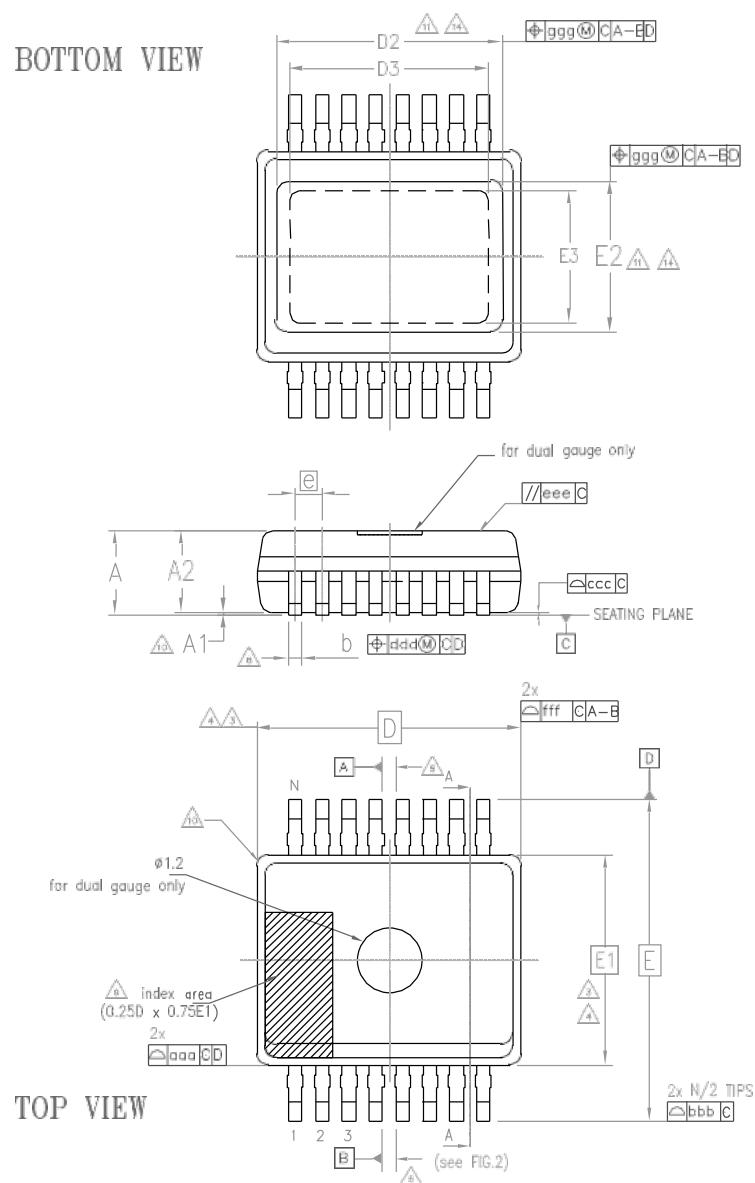
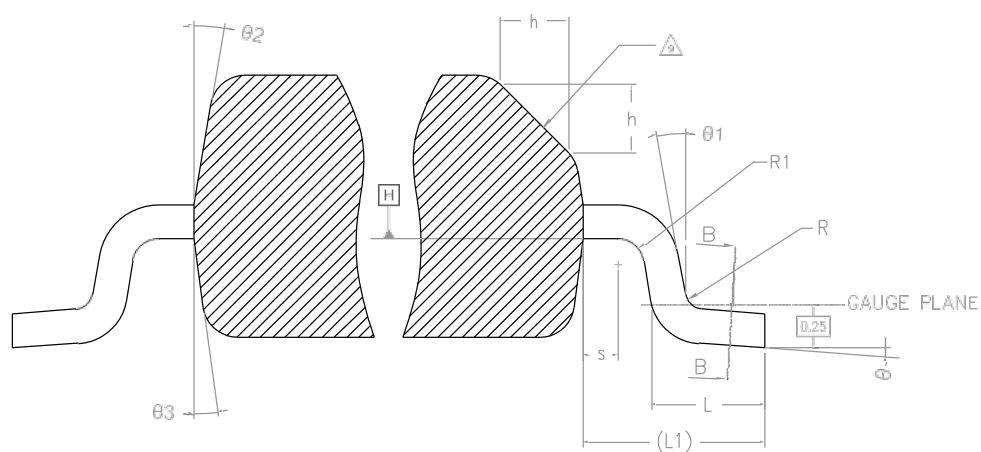
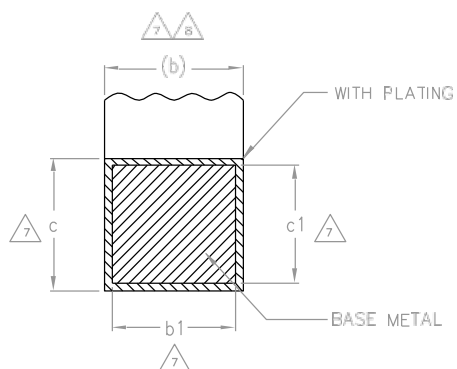


Figure 50. PowerSSO-16 package dimensions (B)

## SECTION A-A



## SECTION B-B

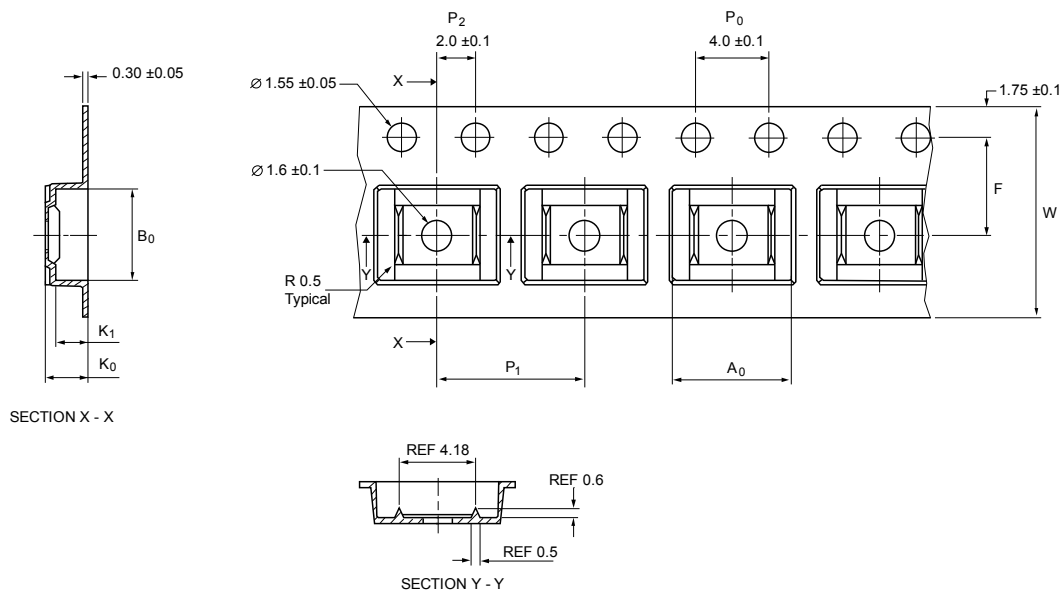


**Table 17. PowerSSO-16 mechanical data**

| Symbol     | Min.                           | Nom. | Max. | Note |
|------------|--------------------------------|------|------|------|
| $\Theta$   | 0°                             | -    | 8°   |      |
| $\Theta 1$ | 0°                             | -    | -    |      |
| $\Theta 2$ | 5°                             | -    | 15°  |      |
| $\Theta 3$ | 5°                             | -    | 15°  |      |
| A          | -                              | -    | 1.70 |      |
| A1         | 0.00                           | -    | 0.10 | 10   |
| A2         | 1.10                           | -    | 1.60 |      |
| b          | 0.20                           | -    | 0.30 | 7,8  |
| b1         | 0.20                           | 0.25 | 0.28 | 7,8  |
| c          | 0.19                           | -    | 0.25 | 7    |
| c1         | 0.19                           | 0.20 | 0.23 | 7    |
| D          | 4.90 BSC                       |      |      | 3,4  |
| D2         | 3.60                           | -    | 4.20 |      |
| D3         | 2.90                           | -    | -    |      |
| e          | 0.50 BSC                       |      |      |      |
| E          | 6.00 BSC                       |      |      |      |
| E1         | 3.90 BSC                       |      |      | 3,4  |
| E2         | 1.90                           | -    | 2.50 |      |
| E3         | 1.20                           | -    | -    |      |
| h          | 0.25                           | -    | 0.50 | 9    |
| L          | 0.40                           | 0.60 | 0.85 |      |
| L1         | 1.00 REF                       |      |      |      |
| N          | 16                             | 6    |      |      |
| R          | 0.07                           | -    | -    |      |
| R1         | 0.07                           | -    | -    |      |
| S          | 0.20                           | -    | -    |      |
| Symbol     | Tolerance of form and position |      |      |      |
|            | Databook                       |      |      |      |
| aaa        | 0.10                           |      |      |      |
| bbb        | 0.10                           |      |      |      |
| ccc        | 0.08                           |      |      |      |
| ddd        | 0.08                           |      |      |      |
| eee        | 0.10                           |      |      |      |
| ffff       | 0.10                           |      |      |      |
| ggg        | 0.15                           |      |      |      |
| NOTE       | 1,2                            |      |      |      |
| REF        |                                |      |      |      |

## 7.2 PowerSSO-16 packing information

**Figure 51. PowerSSO-16 reel 13"**



**Table 18. Reel dimensions**

| Description    | Value <sup>(1)</sup> |
|----------------|----------------------|
| Base quantity  | 2500                 |
| Bulk quantity  | 2500                 |
| A (max)        | 330                  |
| B (min)        | 1.5                  |
| C (+0.5, -0.2) | 13                   |
| D (min)        | 20.2                 |
| N              | 100                  |
| W1 (+2 /-0)    | 12.4                 |
| W2 (max)       | 18.4                 |

1. All dimensions are in mm.

**Figure 52. PowerSSO-16 carrier tape**

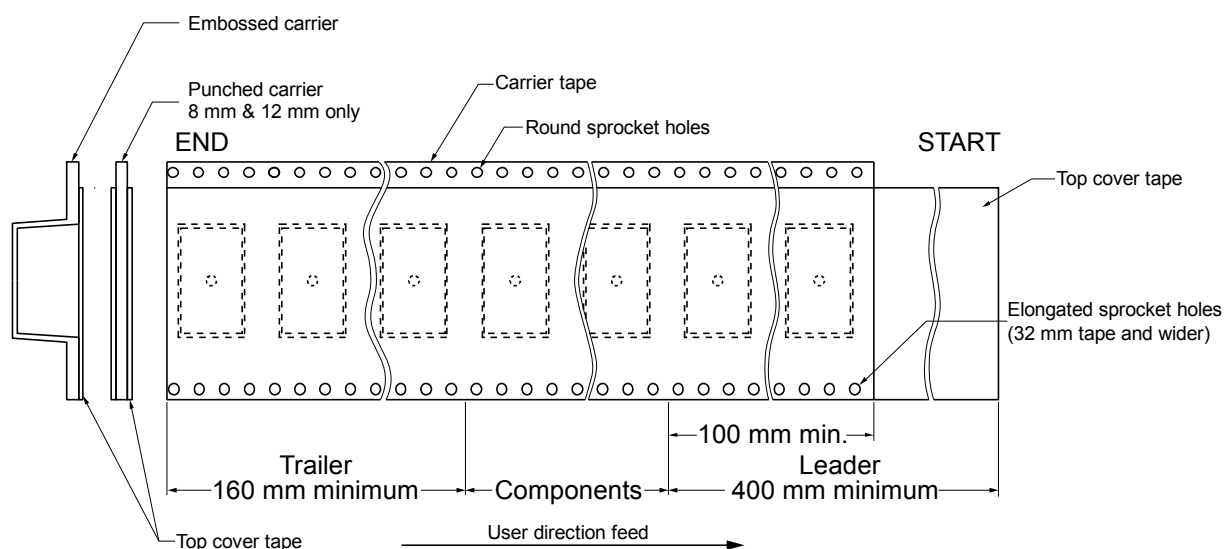
**Table 19. PowerSSO-16 carrier tape dimensions**

| Description    | Value <sup>(1)</sup> |
|----------------|----------------------|
| A <sub>0</sub> | 6.50 ± 0.1           |
| B <sub>0</sub> | 5.25 ± 0.1           |
| K <sub>0</sub> | 2.10 ± 0.1           |
| K <sub>1</sub> | 1.80 ± 0.1           |
| F              | 5.50 ± 0.1           |

| Description    | Value <sup>(1)</sup> |
|----------------|----------------------|
| P <sub>1</sub> | 8.00 ± 0.1           |
| W              | 12.00 ± 0.3          |

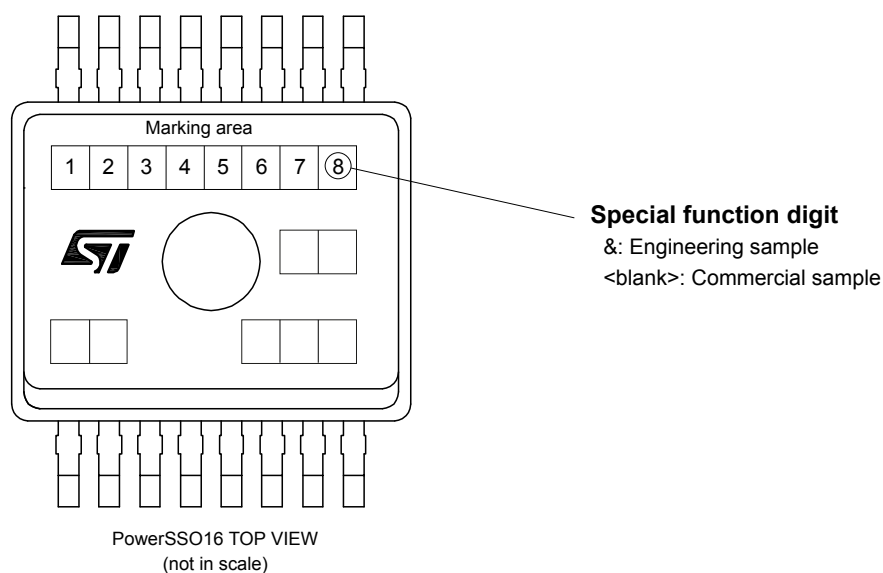
1. All dimensions are in mm.

**Figure 53. PowerSSO-16 schematic drawing of leader and trailer tap**



### 7.3 PowerSSO-16 marking information

**Figure 54. PowerSSO-16 marking information**



Parts marked as '&' are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted prior to any decision to use these engineering samples to run a qualification activity.

## 8 Order codes

**Table 20. Order codes**

| Package     | Order codes |               |
|-------------|-------------|---------------|
|             | Tube        | Tape and reel |
| PowerSSO-16 | —           | VND7020AJTR   |



## Revision history

**Table 21. Document revision history**

| Date        | Revision | Changes                                                                                                                                                                                       |
|-------------|----------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 04-Feb-2015 | 1        | Initial release.                                                                                                                                                                              |
| 25-Oct-2017 | 2        | Added <i>Section 7.2: "PowerSSO-16 packing information"</i> and <i>Section 7.3: "PowerSSO-16 marking information"</i> ; Feature "AEC-Q100 qualified" and automotive icon added on cover page. |
| 17-Oct-2025 | 3        | Updated <a href="#">Section 7.1</a> and <a href="#">Section 7.2</a>                                                                                                                           |

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